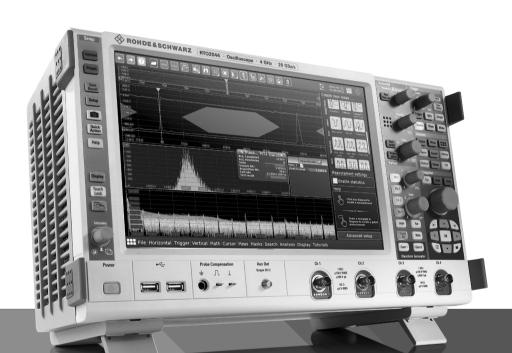
R&S®RTO OSCILLOSCOPE

Specifications





Data Sheet



Ihr Ansprechpartner / Your Partner:

dataTec AG

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>>> www.datatec.eu

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Definitions

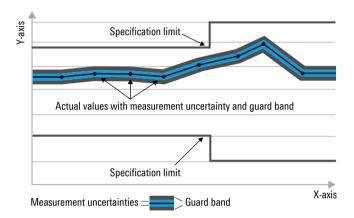
Genera

Product data applies under the following conditions:

- Three hours storage at ambient temperature followed by 30 minutes warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- · All internal automatic adjustments performed, if applicable

Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as <, \le , \ge , \pm , or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP/3GPP2 standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bit per second (Gbps), million bit per second (Mbps), thousand bit per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Msps, ksps, ksps and Msample/s are not SI units.

Base unit

Vertical system

Input channels	R&S®RTO2002	2 channels	
input chamileis	R&S®RTO2004	4 channels	
	R&S®RTO2012	2 channels	
	R&S®RTO2014	4 channels	
	R&S®RTO2022	2 channels	
	R&S®RTO2024	4 channels	
	R&S®RTO2032	2 channels	
	R&S®RTO2034	4 channels	
	R&S®RTO2044	4 channels	
	R&S®RTO2044	4 channels	
Input impedance	K&S*K1O2004	50 Ω ± 3.5 %	
mput impedance		$(50 \Omega \pm 1.5 \% \text{ from +15 °C to +30 °C}),$ 1 MΩ ± 1 % 15 pF (meas.)	
Analog bandwidth (-3 dB)	at 50 Ω input impedance		
,	R&S®RTO2002 and R&S®RTO2004	≥ 600 MHz	
	R&S®RTO2012 and R&S®RTO2014	≥ 1 GHz	
	R&S®RTO2022 and R&S®RTO2024	≥ 2 GHz	
	R&S®RTO2032 and R&S®RTO2034	≥ 3 GHz	
	R&S®RTO2044	≥ 4 GHz	
	R&S®RTO2064	≥ 6 GHz on 2 channels.	
	1.00 1.1.02001	≥ 4 GHz on 4 channels	
	at 1 MΩ input impedance	≥ 500 MHz (meas.)	
Analog bandwidth limits	max. –1.5 dB, min. –4 dB	200 MHz, 20 MHz	
Rise time/fall time	10 % to 90 % at 50 Ω (meas.)	200 12, 20 12	
tioo tirro, rair tirro	R&S®RTO2002 and R&S®RTO2004	510 ps	
	R&S®RTO2012 and R&S®RTO2014	280 ps	
	R&S®RTO2022 and R&S®RTO2024 140 ps		
	R&S®RTO2032 and R&S®RTO2034	116 ps	
	R&S®RTO2044	100 ps	
	R&S®RTO2064 76 ps		
Input VSWR	input frequency	R&S®RTO2002, R&S®RTO2004,	
mput vovvit	input nequency	R&S®RTO2012, R&S®RTO2014, R&S®RTO2022, R&S®RTO2024, R&S®RTO2032, R&S®RTO2034, R&S®RTO2044	
	≤ 2 GHz	1.25 (meas.)	
	> 2 GHz	1.4 (meas.)	
	input frequency	R&S®RTO2064	
	≤ 2 GHz	1.25 (meas.)	
	> 2 GHz to ≤ 4 GHz	1.6 (meas.)	
	> 4 GHz	2.0 (meas.)	
Vertical resolution		8 bit, 16 bit for high resolution decimation (with reduction of the sampling rate), 16 bit for high definition mode (without reduction of the sampling rate ¹	
Effective number of bits of digitizer	for full-scale sine-wave signal with 57.0 bit (meas.) frequency equal to or lower than -3 dB bandwidth		
DC gain accuracy	offset and position set to 0 V, after self-ali	gnment	
-	at 50 Ω, input sensitivity > 5 mV/div	±1.5 %	
	at 50 Ω, input sensitivity ≤ 5 mV/div	±2 %	
	at 1 M Ω	±2 %	
Input coupling	at 50 Ω	DC, GND	
	at 1 MΩ	DC, AC (> 7 Hz), GND	

 $^{^{\}rm 1}$ $\,$ The maximum realtime sampling rate in the high definition mode is 5 Gsample/s.

Inner 1 20-20-	-1.50.0	4 VII-P 1 4 VII-P		
Input sensitivity	at 50 Ω	1 mV/div to 1 V/div,		
		entire analog bandwidth supported for all		
		input sensitivities		
	at 1 MΩ	1 mV/div to 10 V/div,		
		entire analog bandwidth supported for all		
		input sensitivities		
Maximum input voltage	at 50 Ω	5 V (RMS)		
	at 1 M Ω 150 V (RMS), 200 V (V _p),			
		derates at 20 dB/decade to 5 V (RMS)		
		above 250 kHz		
	at 1 MΩ with R&S®RT-ZP10 passive probe	400 V (RMS), 1650 V (V _p),		
		300 V (RMS) CAT II		
		For derating and details,		
		see R&S®RT-Zxx Standard Probes data		
		sheet (PD 3607.3851.22)		
Position range		±5 div		
Offset range at 50 Ω	input sensitivity			
	> 316 mV/div to ≤ 1 V/div	±10 V		
	> 100 mV/div to ≤ 316 mV/div	±3 V		
	1 mV/div to ≤ 100 mV/div	±1 V		
Offset range at 1 MΩ	input sensitivity			
	> 3.16 V/div to ≤ 10 V/div	±(115 V – input sensitivity × 5 div)		
	> 1 V/div to ≤ 3.16 V/div	±100 V		
	> 316 mV/div to ≤ 1 V/div	±(11.5 V – input sensitivity × 5 div)		
	> 100 mV/div to ≤ 316 mV/div	±10 V		
	> 31.6 mV/div to ≤ 100 mV/div	±(1.15 V – input sensitivity × 5 div)		
	1 mV/div to ≤ 31.6 mV/div	±1 V		
Offset accuracy		±(0.35 % × net offset +		
-		2.5 mV + 0.1 div × input sensitivity)		
		(net offset =		
		offset – position × input sensitivity)		
DC measurement accuracy	after adequate suppression of	±(DC gain accuracy ×		
-	measurement noise using high-resolution	reading - net offset		
	sampling mode or waveform averaging or	+ offset accuracy)		
	a combination of both			
Channel-to-channel isolation	input frequency			
(each channel at same input sensitivity)	≤ 2 GHz	> 60 dB		
,	> 2 GHz to ≤ 4 GHz	> 50 dB		
	> 4 GHz to ≤ 6 GHz	> 40 dB		
	11 1 1	I.		

RMS noise floor at 50 Ω (typ.)	input sensitivity	R&S [®] RTO2002, R&S [®] RTO2004	R&S [®] RTO2012, R&S [®] RTO2014
	1 mV/div	0.07 mV	0.10 mV
	2 mV/div	0.08 mV	0.10 mV
	5 mV/div	0.11 mV	0.13 mV
	10 mV/div	0.18 mV	0.22 mV
	20 mV/div	0.33 mV	0.40 mV
	50 mV/div	0.78 mV	0.95 mV
	100 mV/div	1.53 mV	1.88 mV
	200 mV/div	3.05 mV	3.75 mV
	500 mV/div	7.95 mV	9.60 mV
	1 V/div	15.3 mV	18.9 mV
	input sensitivity	R&S [®] RTO2022, R&S [®] RTO2024	R&S [®] RTO2032, R&S [®] RTO2034
	1 mV/div	0.16 mV	0.18 mV
	2 mV/div	0.16 mV	0.19 mV
	5 mV/div	0.16 mV	0.19 mV
	10 mV/div	0.32 mV	0.22 mV
	20 mV/div	0.52 mV	0.63 mV
	50 mV/div	1.45 mV	1.55 mV
	100 mV/div	2.85 mV	3.05 mV
	200 mV/div	5.50 mV	6.05 mV
	500 mV/div	14.2 mV	15.6 mV
	1 V/div	28.8 mV	31.2 mV
		R&S®RTO2044	
	input sensitivity 1 mV/div	0.22 mV	R&S®RTO2064 0.33 mV
	2 mV/div	0.22 mV	0.33 mV
	5 mV/div	0.22 mV	0.33 mV
	10 mV/div	0.39 mV	0.47 mV
	20 mV/div	0.72 mV	0.80 mV
	50 mV/div	1.75 mV	1.90 mV
	100 mV/div	3.40 mV	3.55 mV
	200 mV/div	6.95 mV	7.20 mV
	500 mV/div	17.9 mV	18.9 mV
DMC raise flagrat 4 MO (mass)	1 V/div	35.6 mV	37.3 mV
RMS noise floor at 1 M Ω (meas.)	input sensitivity	0.40 \	
	1 mV/div	0.13 mV	
	2 mV/div	0.13 mV	
	5 mV/div	0.17 mV	
	10 mV/div	0.26 mV	
	20 mV/div	0.47 mV	
	50 mV/div	1.15 mV	
	100 mV/div	2.30 mV	
	200 mV/div	4.70 mV	
	500 mV/div	11.5 mV	
	1 V/div	23.0 mV	
	2 V/div	46.0 mV	
	5 V/div	115 mV	
	10 V/div	230 mV	

Horizontal system

Timebase range		selectable between 25 ps/div and 10 000 s/div,		
		time per div settable to any value within		
		range		
Channel deskew		±100 ns		
Reference position		00 % to 100 % of measurement display area		
Trigger offset range	max.	+(memory depth/current sampling rate)		
	min.	-10 000 s		
Modes		normal, roll		
Channel-to-channel skew		< 100 ps (meas.)		
Timebase accuracy	standard			
	after delivery/calibration, at +23 °C	±5 ppm		
	during calibration interval	±10 ppm		
	with R&S®RTO-B4 option			
	after delivery/calibration, at +23 °C	±0.02 ppm		
	during calibration interval	±0.2 ppm		
	long-term stability (more than one year since calibration)	$\pm (0.1 + 0.1 \times \text{years since calibration}) \text{ ppm}$		
Delta time accuracy	corresponds to time error between two edges on same acquisition and channel; signal amplitude greater than 5 divisions, measurement threshold set to 50 %, vertical gain 10 mV/div or greater; rise time lower than four sample periods; waveform acquired in realtime mode	±(K/realtime sampling rate + timebase accuracy × reading) (peak) (meas.) where K = 0.15 (R&S®RTO2002, R&S®RTO2004) K = 0.18 (R&S®RTO2012, R&S®RTO2014) K = 0.25 (R&S®RTO2022, R&S®RTO2024) K = 0.37 (R&S®RTO2032, R&S®RTO2034) K = 0.43 (R&S®RTO2044) K = 0.55 (R&S®RTO2064)		

Acquisition system

Realtime sampling rate	R&S®RTO2002, R&S®RTO2004, R&S®RTO2012, R&S®RTO2014, R&S®RTO2022, R&S®RTO2024, R&S®RTO2032, R&S®RTO2034,	max. 10 Gsample/s on each channel			
	R&S®RTO2044, R&S®RTO2064	max. 10 Gsample/s on 4 channels, max. 20 Gsample/s on 2 channels			
Realtime waveform acquisition rate	max.	> 1 000 000 waveforms/s			
Memory depth ²	standard				
, ,	R&S®RTO2002, R&S®RTO2012,	50 Msample on 2 channels,			
	R&S®RTO2022, R&S®RTO2032	100 Msample on 1 channel			
	R&S®RTO2004, R&S®RTO2014,	50 Msample on 4 channels,			
	R&S®RTO2024, R&S®RTO2034, R&S®RTO2044, R&S®RTO2064	100 Msample on 2 channels, 200 Msample on 1 channel			
	R&S®RTO-B101 option	200 Maampie on 1 channel			
	R&S®RTO2002, R&S®RTO2012,	100 Msample on 2 channels,			
	R&S®RTO2002, R&S®RTO2032	200 Msample on 1 channel			
	R&S®RTO2004, R&S®RTO2014,	100 Msample on 4 channels,			
	R&S®RTO2004, R&S®RTO2014,	200 Msample on 2 channels,			
	R&S®RTO2044, R&S®RTO2064	400 Msample on 1 channel			
	R&S®RTO-B102 option	400 Msample on 1 channel			
	R&S®RTO2002, R&S®RTO2012,	200 Msample on 2 channels,			
	R&S®RTO2022, R&S®RTO2032 R&S®RTO2004, R&S®RTO2014,	400 Msample on 1 channel			
	R&S®RTO2004, R&S®RTO2014, R&S®RTO2024, R&S®RTO2034,	200 Msample on 4 channels, 400 Msample on 2 channels,			
		·			
	R&S®RTO2044, R&S®RTO2064 800 Msample on 1 channel R&S®RTO-B104 option				
	R&S®RTO2002, R&S®RTO2012,	400 Msample on 2 channels,			
	R&S®RTO2022, R&S®RTO2032	800 Msample on 1 channel			
	R&S®RTO2004, R&S®RTO2014,	400 Msample on 4 channels,			
	R&S®RTO2024, R&S®RTO2034,	800 Msample on 2 channels (restriction:			
	R&S®RTO2044, R&S®RTO2064	400 Msample on 2 channels when Ch1			
	100 1000000 10000000000000000000000000	and Ch2 or Ch3 and Ch4 are turned on),			
		800 Msample on 1 channel			
	R&S®RTO-B110 option	oce meample on a chaine.			
	R&S®RTO2002, R&S®RTO2012,	1 Gsample on 2 channels,			
	R&S®RTO2022, R&S®RTO2032	2 Gsample on 1 channel			
	R&S®RTO2004, R&S®RTO2014,	1 Gsample on 4 channels,			
	R&S®RTO2024, R&S®RTO2034,	2 Gsample on 2 channels (restriction:			
	R&S®RTO2044, R&S®RTO2064	1 Gsample on 2 channels when Ch1 and			
	1,145 1,145 1,145 1,1525 1	Ch2 or Ch3 and Ch4 are turned on),			
		2 Gsample on 1 channel			
Realtime digital filters	selectable for the data acquisition and/o	·			
 	lowpass	cutoff frequency selectable from 100 kHz			
		to 50 % of analog bandwidth			
Decimation modes	sample first sample in decimation inter				
	peak detect	largest and smallest sample in decimation interval			
	high resolution	average value of samples in decimation interval			
	root mean square	root of squared average of samples in decimation interval			

_

² The maximum available memory depth depends on the bit depth of the acquired data and, therefore, on the settings of the acquisition system, such as decimation mode, waveform arithmetic, number of waveform streams or high definition mode.

Waveform arithmetic	off	no arithmetic		
	envelope	envelope of acquired waveforms		
	average	average of acquired waveforms,		
		max. average depth depends on		
		decimation mode ³		
	sample	max. 16 777 215		
	high resolution	max. 65 535		
	root mean square	max. 255		
	reset condition	no reset (standard), reset by time, reset by		
		number of processed waveforms		
Waveform streams per channel		up to 3 with independent selection of		
		decimation mode and waveform arithmetic		
Sampling modes	realtime mode	max. sampling rate set by digitizer		
	interpolated time	enhancement of sampling resolution by		
		interpolation; max. equivalent sampling		
		rate is 4 Tsample/s		
Interpolation modes		linear, sin(x)/x, sample&hold		
Ultra-segmented mode	continuous recording of waveforms in acq	uisition memory without interruption due to		
	visualization	visualization		
	max. realtime waveform acquisition	> 2 500 000 waveforms/s		
	rate			
	min. blind time between consecutive acquisitions	< 300 ns		

Differential signals

General description	Calculation of differential and common mode signals from p part and n part connected to separate input channels. Because of the R&S®RTO digital trigger concept, these signals can be used as a trigger input.	
Input channels		channel 1, channel 2, channel 3, channel 4
Differential signal	difference between two input channels	channel 1 and channel 2, channel 3 and channel 4
Common mode signal	sum of two input channels	channel 1 and channel 2, channel 3 and channel 4
Maximum number of outputs	differential signals common mode signals	2 2

High definition mode

General description	using digital filtering, leading to a	The high definition mode increases the numeric resolution of the waveform signal by using digital filtering, leading to a reduced noise. Because of the digital trigger concept of the R&S®RTO, the signals with increased numeric resolution are used as input for triggering.		
Numeric resolution	R&S [®] RTO2002/2004, R&S [®] RTO2 R&S [®] RTO2032/2034, R&S [®] RTO2			
	bandwidth	bit resolution		
	10 kHz to 50 MHz	16 bit		
	100 MHz	14 bit		
	200 MHz	13 bit		
	300 MHz	12 bit		
	500 MHz	12 bit		
	1 GHz	10 bit		
	R&S®RTO2044/2064 (2 channels	R&S®RTO2044/2064 (2 channels)		
	bandwidth	bit resolution		
	10 kHz to 200 MHz	16 bit		
	300 MHz	12 bit		
	500 MHz	12 bit		
	1 GHz	11 bit		
	2 GHz	10 bit		

³ Waveform averaging is not compatible with peak detect decimation.

Realtime sampling rate	R&S®RTO2002/2004, R&S®RTO2012/2014, R&S®RTO2022/2024, R&S®RTO2032/2034, R&S®RTO2044/2064 (4 channels)		max. 5 Gsample	max. 5 Gsample/s on each channel	
		R&S®RTO2044/2064 (2 channels)		max. 10 Gsample/s on each channel	
Input sensitivity		1100 1110201 112001 (2 0110111010)		range is extended down to μV/div is a magnification setting.	
RMS noise floor at 50 Ω (meas.)	bandwidth	input sensitivity	·	-	
		1 mV/div	10 mV/div	100 mV/div	
	10 MHz	10 μV	18 μV	150 μV	
	100 MHz	31 µV	56 μV	470 μV	
	500 MHz	63 µV	110 μV	960 μV	
	1 GHz	92 μV	170 µV	1.41 mV	
	2 GHz	140 µV	220 µV	1.78 mV	

Trigger system

Sources	R&S®RTO2002, R&S®RTO2012,	channel 1, channel 2
	R&S®RTO2022, R&S®RTO2032	
	R&S®RTO2004, R&S®RTO2014,	channel 1, channel 2, channel 3, channel 4
	R&S®RTO2024, R&S®RTO2034,	
	R&S®RTO2044, R&S®RTO2064	
Sensitivity		10 ⁻⁴ div, from DC to instrument bandwidth for all vertical scales
Trigger jitter	full-scale sine wave of frequency set to -3 dB bandwidth	< 1 ps (RMS) (meas.)
Coupling mode	standard	same as selected channel
	lowpass filter	cutoff frequency selectable from 100 kHz
		to 50 % of analog bandwidth
Sweep mode		auto, normal, single, n single
Event rate	max.	one event for every 400 ps time interval
Trigger level	range	±5 div from center of screen
Trigger hysteresis	modes	auto (standard) or manual
	sensitivity	10 ⁻⁴ div, from DC to instrument bandwidth
		for all vertical scales
Holdoff range	time	100 ns to 10 s, fixed and random
-	events	1 event to 2 000 000 000 events

Main trigger modes			
Edge	triggers on specified slope (pos	triggers on specified slope (positive, negative or either) and level	
Glitch	triggers on glitches of positive, specified width	triggers on glitches of positive, negative or either polarity that are shorter or longer than specified width	
	glitch width	100 ps to 1000 s	
		50 ps to 1000 s	
		(R&S®RTO2044, R&S®RTO2064)	
Width	triggers on positive or negative	pulse of specified width; width can be shorter, longer,	
	inside or outside the interval		
	pulse width	100 ps to 1000 s	
		50 ps to 1000 s	
		(R&S®RTO2044, R&S®RTO2064)	
Runt		triggers on pulse of positive, negative or either polarity that crosses one threshold but	
		fails to cross a second threshold before crossing the first one again; runt pulse width	
	can be arbitrary, shorter, longer	can be arbitrary, shorter, longer, inside or outside the interval	
	runt pulse width	100 ps to 1000 s	
		50 ps to 1000 s	
		(R&S®RTO2044, R&S®RTO2064)	
Window		xits a specified voltage range; triggers also when signal	
Timeout		stays inside or outside the voltage range for a specified period of time triggers when signal stays high, low or unchanged for a specified period of time	
rimeout	tinggers when signal stays high,	100 ps to 1000 s	
	umeout		
		50 ps to 1000 s	
		(R&S®RTO2044, R&S®RTO2064)	

Interval		triggers when time between two consecutive edges of same slope (positive or negative) is shorter, longer, inside or outside a specified range	
	interval time	100 ps to 1000 s	
		50 ps to 1000 s	
		(R&S®RTO2044, R&S®RTO2064)	
Slew rate	triggers when the time required I	by a signal edge to toggle between user-defined upper	
	and lower voltage levels is short may be positive, negative or eith	er, longer, inside or outside the interval; edge slope er	
	toggle time	100 ps to 1000 s	
		50 ps to 1000 s	
		(R&S [®] RTO2044, R&S [®] RTO2064)	
Data2clock	two input channels; monitored tir	triggers on setup time and hold time violations between clock and data present on any two input channels; monitored time interval may be specified by the user in the range from –100 ns to 100 ns around a clock edge and must be at least 100 ps wide	
Pattern	triggers when a logical combination (and, nand, or, nor) of the input channels stays true for a period of time shorter, longer, inside or outside a specified range		
State	triggers when a logical combination (and, nand, or, nor) of the input channels stays true at a slope (positive, negative or either) in one selected channel		
Serial pattern	triggers on serial data pattern up to 128 bit clocked by one input channel; pattern bits		
	may be high (H), low (L) or don't care (X); clock edge slope may be positive, negative or either; hardware CDR selectable as clock source (requires R&S®RTO-K13 option)		
	max. data rate	< 2.50 Gbps	
		< 5 Gbps (R&S®RTO2044, R&S®RTO2064)	
TV/video		gressive and interlaced video signals including NTSC, d HDTV broadcast standards as well as custom bi-level is	
	trigger modes	all fields, odd fields, even fields, all lines, line number	

Advanced trigger modes		
Trigger qualification	trigger events may be qualified by a logical combination of unused channels	
	qualifiable events	edge, glitch, width, runt, window, timeout, interval
Sequence trigger (A/B/R trigger)	triggers on B event after occurrence of A event; delay condition after A event specified either as time interval or number of B events; an optional R event resets the trigger sequence to A	
	A event	any trigger mode
	B event	edge, glitch, width, runt, window, timeout, interval, slew rate
	R event	edge, glitch, width, runt, window, timeout, interval, slew rate
Zone trigger		with R&S®RTO-K19 option
Serial bus trigger	optional	see dedicated triggering and decoding options
NFC trigger		with R&S®RTO-K11 option
CDR trigger	triggers on clock signal recovered from the trigger source signal; phase of the trigger instant user-selectable as fraction of bit period; requires R&S®RTO-K13 option	
	CDR configuration parameters	PLL order (first or second), nominal bit rate, loop bandwidth, relative bandwidth, damping factor, unit interval offset
	CDR bit rate range	
	R&S®RTO2002, R&S®RTO2004, R&S®RTO2012, R&S®RTO2014, R&S®RTO2022, R&S®RTO2024	200 kbps to 2.5 Gbps
	R&S®RTO2044, R&S®RTO2064	200 kbps to 2.5 Gpbs standard, 400 kbps to 5.0 Gbps when operating at 20 Gsample/s realtime sampling rate ⁴

⁴ The frontends of the R&S®RTO2044 and the R&S®RTO2064 sample at 20 Gsample/s when at most one channel from each pair {channel1, channel2} and {channel3, channel4} is active; and the user-selected sampling resolution in realtime sampling mode or interpolated time sampling mode is 50 ps or smaller.

External trigger input	input impedance	50 Ω ± 1.5 % or
	' '	1 MΩ ± 1 % 20 pF (meas.)
	max. input voltage at 50 Ω	5 V (RMS)
	max. input voltage at 1 MΩ	30 V (RMS)
		derates at 20 dB/decade to 5 V (RMS)
		above 25 MHz
	trigger level	±5 V
	sensitivity	
	input frequency ≤ 100 MHz	300 mV (V _{pp})
	100 MHz < input frequency ≤ 500 MHz	600 mV (V _{pp})
	input coupling	AC, DC (50 Ω and 1 M Ω), GND,
		HF reject (attenuates > 50 kHz or
		> 50 MHz, user-selectable),
		LF reject (attenuates < 5 kHz or < 50 kHz,
		user-selectable)
	trigger modes	edge (rise or fall)
Trigger out	functionality	a pulse is generated for every acquisition
		trigger event
	output voltage	0 V to 5 V at high impedance;
		0 V to 2.5 V at 50 Ω
	pulse width	selectable between 50 ns and 60 ms
	pulse polarity	low active or high active
	output delay	depends on trigger settings
	jitter	±600 ps (meas.)

RF characteristics ⁵

Sensitivity/noise density	at 1.001 GHz (measurement of the power spectral density at 1.001 GHz at input sensitivity 1 mV/div, corresponding to –36 dBm input range of the oscilloscope, using the FFT with center frequency 1.001 GHz, span 500 kHz, RBW 3 kHz)	–159 dBm (1 Hz) (meas.)
	at 100 kHz (measurement of the power spectral density at 100 kHz at input sensitivity 1 mV/div, corresponding to –36 dBm input range of the oscilloscope, using the FFT with center frequency 100 kHz, span 20 kHz, RBW 200 Hz)	- 156 dBm (1 Hz) (meas.)
Noise figure	at 1.001 GHz (calculated based on the noise density above)	15 dB (meas.)
	at 100 kHz (calculated based on the noise density above)	18 dB (meas.)
Signal-to-noise ratio	measured for an input carrier with frequency 1 GHz and level 0 dBm at input sensitivity 70 mV/div, corresponding to 0 dBm input range of the oscilloscope, using the FFT with center frequency 1 GHz, span 100 MHz, RBW 400 Hz at +20 MHz from the center frequency	112 dB (meas.)
Absolute amplitude accuracy	0 to 5 GHz	±1 dB (meas.)
Spurious-free dynamic range	measured for an input carrier with frequency 950 MHz and level 0 dBm at input sensitivity 70 mV/div, corresponding to 0 dBm input range of the oscilloscope, using the FFT with center frequency 2 GHz, span 4 GHz, RBW 100 kHz	68 dBc (meas.)

⁵ The RF characteristics are measured for an R&S®RTO2064 oscilloscope with 6 GHz bandwidth.

Second harmonic distortion	measured for an input carrier with frequency 950 MHz and level 0 dBm at input sensitivity 70 mV/div, corresponding to 0 dBm input range of the oscilloscope, using the FFT with center frequency 950 MHz, span 4 GHz, RBW 100 kHz	-49 dBc (meas.)
Third harmonic distortion	measured for an input carrier with frequency 950 MHz and level 0 dBm at input sensitivity 70 mV/div, corresponding to 0 dBm input range of the oscilloscope, using the FFT with center frequency 950 MHz, span 4 GHz, RBW 100 kHz	-44 dBc (meas.)

Waveform measurements

General features	measurement panels	up to 8 measurement panels; each panel may contain any number of automatic measurements of the same category
	gate	delimits the display region evaluated for automatic measurements
	reference levels	user-configurable vertical levels define support structures for automatic measurements
	statistics	displays maximum, minimum, mean, standard deviation, RMS and measurement count for each automatic measurement
	track	measurement results displayed as continuous trace that is time-correlated to the measurement source
	long-term analysis	history of selected measurements as trace against count index
	histogram	available for the main measurement of each measurement panel; automatic or manual selection of bin number and scale; counters for measurements under, within and over the histogram range
	limit check	measurements tested against user-defined margins and limits; pass or fail conditions may launch automatic response: acquisition stop, beep, print and save waveform

Measurement category	amplitude and time	amplitude, high, low, maximum, minimum, peak-to-peak, mean, RMS, sigma, overshoot, area, rise time, fall time, positive width, negative width, period, frequency, duty cycle, delay, phase, burst width, pulse count, positive switching, negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, setup/hold time, setup/hold ratio, pulse train, slew rate rising, slew rate falling, DC voltmeter (requires Rohde & Schwarz active probe with R&S®ProbeMeter functionality)
	eye diagram	extinction ratio, eye height, eye width, eye top, eye base, crossing points, Q factor, S/N ratio, duty cycle distortion, eye rise time, eye fall time, eye bit rate, eye amplitude, jitter (peak-to-peak, 6-sigma, RMS)
	optical	optical average power, optical modulation amplitude
	spectrum	channel power, bandwidth, occupied bandwidth, harmonic search, total harmonic distortion THD in dB and % using power values, total harmonic distortion variants THDa, THDu and THDr using voltage, overall voltage and overall voltage root means square, peak list (THDa, THDu, THDr and peak list require R&S®RTO-K18 option)
	jitter	cycle-to-cycle jitter, N-cycle jitter, cycle-to-cycle width, cycle-to-cycle duty cycle, time-interval error, data rate, unit interval, skew delay, skew phase; requires R&S®RTO-K12 option
Cursors	setup	up to 4 cursor sets on screen, each set consisting of two horizontal and two vertical cursors
	target	acquired waveforms (input channels), math waveforms, reference waveforms, track waveforms, XY diagrams
	operating mode	vertical measurements, horizontal measurements or both; vertical cursors either set manually or locked to waveform
Histogram	source	acquired waveform (input channels), math waveform, reference waveform
	mode	vertical (for timing statistics), horizontal (for amplitude statistics)
	automatic measurements	waveform count, waveform samples, histogram samples, histogram peak, peak value, maximum, minimum, median, range, mean, sigma, mean ± 1, 2 and 3 sigma, marker ± probability

Mask testing

Test definition	number of masks	up to 8 simultaneously	
	source	acquired waveforms (input channels),	
		math waveforms	
	fail condition	sample hit or waveform hit	
	fail tolerance	minimum number of fail events for test fail	
		in range from 0 to 4 000 000 000	
	test rate	up to 600 000 waveforms per second	
	action on error	acquisition stop, beep, print and save waveform	
	save/load to file	test and mask settings (.xml format)	
Mask definition with segments	number of independent segments	up to 8	
	segment definition	array of points and connecting rule (upper, lower, inner) define segment region	
	segment input	point and click on touchscreen, editable list	
Mask definition with tolerance tube	input signal	acquired waveform	
	definition of tolerance tube	horizontal width, vertical width, vertical stretch, vertical position	
Mask definition with eye mask assistant	primary mask shape		
(requires one of the following options:	type	diamond, square, hexagon, octagon	
R&S®RTO-K12/-K91/-K133/-K134)	dimensions	main and secondary height, main and	
		secondary width, depending on selected shape	
	position	vertical offset, horizontal offset	
	secondary mask shapes		
	locations	any combination of left, right, top, bottom	
	position	horizontal and vertical offset with respect	
	'	to center of primary mask shape	
Serial standard masks	multiple predefined protocol masks	D-PHY, M-PHY, C-PHY, PCIe, USB, HDMI™, JESD204C, ITU and Ethernet	
Result statistics	category	completed acquisitions, remaining acquisitions, state, sample hits, mask hits, fail rate, test result (pass or fail)	
Visualization options	waveform style	vectors, dots	
visualization options	violation highlighting	hits (on/off), highlight persistence	
	violation riighiighting	(50 ms to 50 s or infinite), waveform color (default: red)	
	mask colors	configurable colors for mask without violation (default: translucent gray), mask with violation (default: translucent red), mask with contact (default: translucent pale red)	

Waveform math

General features	number of math waveforms	up to 8
	number of reference waveforms	up to 4
	waveform arithmetic	user-selectable average or envelope of consecutive waveforms
Algebraic expressions	user may define complex mathematica measurement results	al expressions involving waveforms and
	math functions	add, subtract, multiply, divide, absolute value, square, square root, integrate, differentiate, exp, log ₁₀ , log _e , log ₂ , rescale, sin, cos, tan, arcsin, arccos, arctan, sinh, cosh, tanh, autocorrelation, crosscorrelation
	logical operators	not, and, nand, or, nor, xor, nxor
	relational operators	Boolean result of $=$, \neq , $>$, $<$, \leq , \geq
	frequency domain	spectral magnitude and phase, real and imaginary spectra, group delay
	digital filter	lowpass, highpass
	special functions	CDR transform; requires R&S®RTO-K12 option

Optimized math	operators	add, subtract, multiply, invert, absolute value, differentiate, log ₁₀ , log _e , log ₂ , rescale, FIR, FFT magnitude
Spectrum analysis	FFT magnitude spectrum	
Spectrum analysis	setup parameters	center frequency, frequency span, frame overlap, frame window (rectangular, Hamming, Hann, Blackman, Gaussian, Flattop, Kaiser Bessel), user-selectable spectrum averaging, RMS, envelope, max. hold and min. hold (max. hold and min. hold require R&S®RTO-K18 option)
	max. realtime waveform acquisition rate	> 1 000 waveforms/s

Search and mark function

General description	scans acquired waveforms for occean occurrence	scans acquired waveforms for occurrence of a user-defined set of events and highlights each occurrence		
Basic setup	source	all physical input channels, math waveforms, reference waveforms		
	search panels	up to 8, where each panel may manage multiple event searches		
	search mode	manually triggered or continuous		
	search conditions			
	supported events	edge, glitch, width, runt, window, timeout, interval, slew rate, data2clock, state		
	event configuration	identical to corresponding trigger event		
	event selection	single or multiple events on same source		
Search oscilloscope	mode	current waveform, gated time interval		
Result visualization	table			
	sort mode	horizontal position or vertical value		
	max. result count	specifies max. table size		
	zoom window	centered on highlighted event		

Display characteristics

Diagram types	Yt, XY, spectrum, long-term measurement, spectrogram (spectrogram requires R&S®RTO-K37 option)	
Horizontal divisions	10	
Vertical divisions	10	
Display interface configuration	display area can be split up into separate diagram areas by dragging and dropping signal icons;	
	each diagram area can hold any number of signals;	
	diagram areas may be stacked on top of each other and later accessed via the dynamic tab menu	
Signal icon	each active waveform is represented by a separate signal icon on the signal bar; the signal icon displays individual vertical and acquisition settings; a waveform can be minimized to signal icon to appears as a realtime preview in miniature; measurement results may also be minimized to a signal icon	
Toolbar	quick access to 28 important tools; directly set most common parameters in a simple menu and access to more detailed parameters in main menu; user-defined selection of tools in toolbar	
Upper menu	displays trigger, horizontal and acquisition settings; quick access to settings	
Main menu	provides access to all instruments settings in compact menu	
Axis label	X-axis ticks and Y-axis ticks labeled with tick value and physical unit	
Diagram label	diagrams may be individually labeled with a descriptive user-defined name	
Diagram layout	grid, crosshair, axis labels and diagram label may be switched on and off separately	
Persistence	50 ms to 50 s, or infinite	
Zoom	user-defined zoom window provides vertical and horizontal zoom; each diagram area supports multiple zoom windows; touchscreen interface simplifies resize and drag operations on zoom window	
Signal colors	predefined or user-defined color tables for persistence display	

Input and output

Front		
Channel inputs		BNC-compatible,
		for details see Vertical system
	probe interface	auto-detection of passive probes,
		Rohde & Schwarz active probe interface
Auxiliary output		SMA connector, for future use
Probe compensation output	signal shape	rectangle, $V_{low} = 0 \text{ V}$, $V_{high} = 1 \text{ V}$
		amplitude 1 V (V _{pp}) ± 5 %
	frequency	1 kHz ± 1 %
	impedance	nom. 50 Ω
Ground jack		connected to ground
USB interface		2 ports, type A plug, version 2.0

Rear	
External trigger input	BNC,
	for details see Trigger system
Trigger out	BNC,
	for details see Trigger system
USB interface	2 ports, type A plug and
	1 port, type B plug, version 3.1 gen 1
LAN interface	RJ-45 connector,
	supports 10/100/1000BASE-T
External monitor interface	DVI-D and DisplayPort,
	output of oscilloscope display or extended
	desktop display
GPIB interface	see R&S®RTO-B10 option
Reference input	see R&S®RTO-B4 option
Reference output	see R&S®RTO-B4 option
Security slot	for standard Kensington style lock

General data

Display	type	12.1" LC TFT color display with capacitive
		touchscreen
	resolution	1280 x 800 pixel (WXGA)
Operating system		Windows 10 64-bit

Temperature		
Temperature loading	operating temperature range	0 °C to +45 °C
	storage temperature range	-40 °C to +70 °C
Temperature loading		in line with MIL-PRF-28800F section
		4.5.5.1.1.1 class 3 tailored to +45 °C for
		operation
Climatic loading		+25° C/+40 °C at 85 % rel. humidity cyclic,
		in line with IEC 60068-2-30
		+30 °C/+40 °C/+45 °C at 95/75/45 % in
		line with MIL-PRF-28800F section
		4.5.5.1.1.2 class 3 tailored to +45 °C for
		operation

Altitude	
Operating	up to 3000 m above sea level
Nonoperating	up to 4600 m above sea level

Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, max. 2 g at 55 Hz; 0.5 g from 55 Hz to 150 Hz; in line with EN 60068-2-6 5 Hz to 55 Hz, in line with MIL-PRF-28800F section
	random	4.5.5.3.2 class 3 8 Hz to 500 Hz, acceleration 1.2 g (RMS), in line with EN 60068-2-64 5 Hz to 500 Hz, acceleration 2.058 g (RMS), in line with MIL-PRF-28800F
Shock		section 4.5.5.3.1 class 3 40 g shock spectrum, in line with MIL-STD-810E, method no. 516.4, procedure I 30 g functional shock, halfsine, duration 11 ms, in line with MIL-PRF-28800F section 4.5.5.4.1

EMC	
RF emission	in line with CISPR 11/EN 55011 group 1
	class A (for a shielded test setup);
	the instrument complies with the emission
	requirements stipulated by EN 55011,
	EN 61326-1 and EN 61326-2-1 class A,
	making the instrument suitable for use in
	industrial environments
Immunity	in line with IEC/EN 61326-1 table 2,
	immunity test requirements for industrial
	environment ⁶

Certifications	VDE, cCSA _{US} , KC

Calibration interval	1 year

 $^{^{6}~}$ Test criterion is displayed noise level within $\pm 1~$ div for input sensitivity of 5 mV/div.

Power supply		
AC supply	100 V to 240 V at	
	50 Hz to 60 Hz and 400 Hz,	
	max. 5.5 A to 2.3 A,	
	in line with MIL-PRF 28800F section 3.5	
Power consumption	max. 450 W	
Safety	in line with IEC 61010-1, EN 61010-1,	
	CAN/CSA-C22.2 No. 61010-1,	
	UL 61010-1	

Mechanical data		
Dimensions	$W \times H \times D$	427 mm × 249 mm × 204 mm
		$(16.81 \text{ in} \times 9.80 \text{ in} \times 8.03 \text{ in})$
Weight	without options, nominal	9.6 kg (21.16 lb)

Options

R&S®RTO-B1 mixed signal option

Mixed signal option, additional 16 logic channels

Vertical system

Input channels		16 logic channels (D0 to D15)
Arrangement of input channels		arranged in two logic probes with
		8 channels each, assignment of the logic
		probes to the channels (D0 to D7 or D8 to
		D15) is displayed on the probe
DC input resistance	at probe tips	100 kΩ ± 2 % (meas.)
Input capacitance		4 pF (meas.)
Maximum input frequency	signal with minimum input voltage swing	400 MHz (meas.)
	and hysteresis setting: normal	
Maximum input voltage		±40 V (V _p)
Minimum input voltage swing		500 mV (V _{pp}) (meas.)
Threshold groups		D0 to D3, D4 to D7, D8 to D11 and D12 to
		D15
Threshold level	range	±8 V in 25 mV steps
	predefined	CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V,
		TTL, ECL, PECL, LVPECL
Threshold accuracy	threshold setting between ±4 V	±(100 mV + 3 % of threshold setting)
		(meas.)
Comparator hysteresis		normal, robust, maximum

Horizontal system

Channel deskew	range for each channel	±200 ns
Channel-to-channel skew		< 500 ps (meas.)

Acquisition system

Sampling rate	max.	5 Gsample/s on each channel
Realtime waveform acquisition rate	max.	> 200 000 waveforms/s
Memory depth	at max. sampling rates	200 Msample for every channel
	at lower sampling rates	100 Msample for every channel
Decimation		pulses lost due to decimation are
		displayed

Trigger system

Holdoff range	time	100 ns to 10 s, fixed and random
	events	1 event to 2 000 000 000 events

Trigger modes		
Edge	triggers on specified slope (positive, negative or either) in the source signal	
	sources	any channel from D0 to D15 or any logical combination of D0 to D15
Width	triggers on positive or negative	pulse of specified width in the source signal; width can
	be shorter, longer, equal, inside	e or outside the interval
	sources	any channel from D0 to D15 or any logical combination of D0 to D15
	pulse width	200 ps to 10 s
Timeout	triggers when the source signa time	I stays high, low or unchanged for a specified period of
	sources	any channel from D0 to D15 or any logical combination of D0 to D15
	timeout	200 ps to 10 s
Data2clock		I time violations between a clock signal and a data with a max. width of 200 ns and a position of cedge
	data signal	any subset of channels from D0 to D15 or any user-defined bus signal
	clock signal	any channel from D0 to D15

Pattern	triggers when the source goes true or stays true for a period of time shorter, longer, equal, inside or outside a specified range	
	sources	any logical combination of D0 to D15 or any user-defined bus signal
	pulse width	200 ps to 10 s
State	triggers on the slope (positive, r matches a user-defined logical	negative or either) of the clock signal when data signal state
	data signal	any logical combination of D0 to D15 or any user-defined bus signal
	clock signal	any channel from D0 to D15
Serial pattern	triggers on a serial data pattern of up to 32 bit; pattern bits may be high (H), low (L) or don't care (X); clock edge slope may be positive, negative or either	
	data signal	any channel from D0 to D15 or any logical combination of D15 to D15
	clock signal	any channel from D0 to D15
	max. data rate	1 Gbps
Serial bus trigger	optional	see dedicated triggering and decoding options
	sources	any channel from D0 to D15

Waveform measurements

General features	measurement panels, gate, statistics,
	long-term analysis and limit check; see
	features of the base unit
Measurement sources	all channels from D0 to D15 or any logical
	combination of D0 to D15
Automatic measurements	positive pulse width, negative pulse width,
	period, frequency, burst width, delay,
	phase, positive duty cycle, negative duty
	cycle, positive pulse count, negative pulse
	count, rising edge count, falling edge
	count
Additional cursor function	display of decoded bus value at the cursor
	position

Display characteristics

Display of logical channels		selectable size and position on screen, diagram configuration by dragging and dropping signal icons
Bus decode	number of bus signals	4
	bus types	unclocked and clocked
	display types	decoded bus, logical signal, bus + logical signal, amplitude + logical signal, tabulated list (decoded time interval selected with cursors)
	position and size	size and position on screen selectable
	data format of decoded bus	hex, unsigned integer, signed integer, fractional, binary
	data format of amplitude signal	unsigned integer, signed integer, fractional, binary offset
Channel activity display		independent of the oscilloscope
		acquisition, the state (stays low, stays high
		or toggles) of the channels from D0 to D15 is displayed in the signal icon

R&S®RTO-B4 OCXO 10 MHz

Timebase accuracy	OCXO	see Horizontal system
Reference output	connector	BNC female
	impedance	nom. 50 Ω)
	output frequency with OCXO	nom. 10 MHz
	output frequency with auxiliary reference	same as auxiliary reference
	level	> 7 dBm
Auxiliary reference input	connector	BNC female
	impedance	nom. 50 Ω
	input frequency range	1 MHz ≤ f _{in} ≤ 20 MHz, in 1 MHz steps
	required level	\geq 0 dBm into 50 Ω

R&S®RTO-B6 arbitrary waveform generator

Arbitrary function/waveform generator, 2 analog channels, 8-bit pattern generator

Analog channels

General	
Output channel	2 channels
Vertical resolution	14 bit
Operating modes	function generator, arbitrary waveform
	generator, modulation, frequency sweep

Function generator	output of predefined waveforms	output of predefined waveforms	
Sample rate		500 Msample/s	
	sine, square/pulse, ramp, DC, noise, sin	e cardinal (sinc), Gaussian pulse, Lorentz,	
	exponential fall, exponential rise, cardiac		
Sine	frequency range	1 mHz to 100 MHz	
	amplitude flatness (relative to 1 kHz)		
	f ≤ 100 kHz	≤ ±0.1 dB	
	100 kHz < f ≤ 60 MHz	≤ ±0.3 dB	
	60 MHz < f ≤ 100 MHz	≤ ±0.5 dB	
	total harmonic distortion (1 V (Vpp) into 5	0 Ω)	
	f ≤ 100 kHz	≤ -70 dBc (= THD ≤ 0.032 %)	
	100 kHz < f ≤ 15 MHz	≤ –55 dBc	
	15 MHz < f ≤ 35 MHz	≤ –40 dBc	
	35 MHz < f ≤ 100 MHz	≤ –30 dBc	
	nonharmonic spurious (1 V (V _{pp}) into 50 Ω)	-65 dBc (meas.)	
	phase noise (meas.)		
	f ≤ 25 MHz	≤ -105 dBc (1 Hz) at 1 kHz offset,	
		≤ -115 dBc (1 Hz) at 10 kHz offset,	
		≤ –125 dBc (1 Hz) at 100 kHz offset	
	25 MHz < f ≤ 100 MHz	≤ -105 dBc (1 Hz) at 1 kHz offset,	
		≤ -110 dBc (1 Hz) at 10 kHz offset,	
		≤ -115 dBc (1 Hz) at 100 kHz offset	
Square/pulse	frequency range	1 mHz to 30 MHz	
	duty cycle (if pulse width limit is not	0.01 % to 99.99 %, 0.01 % resolution	
	exceeded)		
	pulse width	≥ 16.5 ns, 0.1 ns resolution	
	rise/fall time		
	f ≤ 10 Hz	90 μs (meas.)	
	10 Hz < f ≤ 30 MHz	9 ns (meas.)	
	overshoot	≤ 2 %	
	jitter (cycle-to-cycle)	≤ 40 ps (RMS) (meas.)	
Ramp (triangle, sawtooth)	frequency range	1 mHz to 1 MHz	
, (, , , , , , , , , , , , , , , , , ,	linearity	≤ 0.1 % (meas.)	
	variable symmetry	0 % to 100 %, 0.1 % resolution	
DC	level range		
	into 50 Ω	± [3 V – (noise amplitude [V _{pp}] / 2)]	
	into open circuit	$\pm [6 \text{ V} - (\text{noise amplitude } [V_{pp}] / 2)]$	

Noise	amplitude	amplitude	
	DC	0 V to 6 V (V _{pp}) (into 50 Ω)	
		0 V to 12 V (V _{pp}) (into open circuit)	
		4 digits resolution	
	all other waveforms	0 % to 100 % of AC signal amplitude,	
		1 % resolution	
	bandwidth	≥ 100 MHz	
Sine cardinal (sinc)	frequency range	1 mHz to 2 MHz	
Gaussian pulse	frequency range	1 mHz to 10 MHz	
Lorentz	frequency range	1 mHz to 5 MHz	
Exponential rise/fall	frequency range	1 mHz to 1 MHz	
Cardiac	frequency range	1 mHz to 1 MHz	

Arbitrary waveform generator	output of user-defined waveforms	
Waveform length		1 sample to 40 Msample on each channel
Sample rate		1 sample/s to 250 Msample/s
Filter bandwidth		100 MHz

Modulation		
Sample rate		500 Msample/s
Modulation types		amplitude modulation (AM), frequency modulation (FM), frequency-shift key modulation (FSK), pulse width modulation (PWM)
Carrier waveform	AM, FM, FSK	sine
	PWM	square/pulse
AM	modulation signals	sine, square, ramp (triangle, sawtooth)
	modulation frequency	1 mHz to 1 MHz
	depth	0 % to 100 %, 0.1 % resolution
FM	modulation signals	sine, square, triangle, ramp, inverse ramp
	modulation frequency	1 mHz to 1 MHz
	frequency deviation	1 mHz to 10 MHz
FSK	modulation signal	50 % duty cycle square wave
	range of frequency 1, frequency 2	1 mHz to 100 MHz
	hop rate	1 mHz to 1 MHz
PWM	modulation signals	sine, square, ramp
	depth	0 % to 99.99 % of the duty cycle, 0.01 % resolution

Frequency sweep	output of a sinusoidal waveform with the frequency changing linearly between the start frequency and the stop frequency within the sweep time	
	sample rate	500 Msample/s
	waveform	sine
	frequency range	1 mHz to 100 MHz
	direction	up (start frequency < stop frequency)
		down (start frequency > stop frequency)
	sweep time	1 ms to 500 s

Two-channel operation	operating modes	independent channels, coupled parameters, differential
	parameter coupling	none, frequency and/or amplitude
	relative phase	-180° to 180°, 0.1° resolution
	channel-to-channel skew	≤ 200 ps (meas.)
	channel-to-channel isolation	
	(each channel with same output am	plitude)
	f≤10 MHz	≥ 60 dB (meas.)
	10 MHz < f ≤ 100 MHz	≥ 40 dB (meas.)

Outputs		
Connectors		BNC female on the rear panel
Function		on, off, inverted
Output impedance		nom. 50 Ω
Overload protection		a short-circuit to ground is tolerated indefinitely,
		automatic shutoff in case of voltages
		\geq +7 V or \leq -7 V (meas.),
		automatic shutoff in case of overcurrent,
		max20 V to +20 V without damage
		(meas.), ESD protection
Amplitude range 7	sine, square/pulse, ramp, pulse,	, exponential rise, exponential fall
	into 50 Ω	10 mV to 6 V (V _{pp}) (frequency ≤ 50 MHz),
		10 mV to 4 V (V _{pp}) (frequency > 50 MHz)
	into open circuit	20 mV to 12 V (V _{pp}) (frequency ≤ 50 MHz),
	e spon en ean	20 mV to 8 V (V _{DD}) (frequency > 50 MHz)
	sine cardinal (sinc)	
	into 50 Ω	10 mV to 3 V (V _{DD})
	into open circuit	20 mV to 6 V (V _{pp})
	Gauss, Lorentz	20111 (O O V (Vpp)
	into 50 Ω	10 mV to 2.5 V (V _{pp})
		20 mV to 5 V (V _{pp})
	into open circuit	20 111 v to 5 v (v _{pp})
	arbitrary waveforms into 50 Ω	40 // 4 C // (//)
	Into 50 t2	10 mV to 6 V (V _{pp})
		(sample rate ≤ 125 Msample/s),
		10 mV to 4 V (V _{pp})
		(sample rate > 125 Msample/s)
	into open circuit	20 mV to 12 V (V _{pp})
		(sample rate ≤ 125 Msample/s),
		20 mV to 8 V (V_{pp})
		(sample rate > 125 Msample/s)
	resolution	1 mV
	accuracy	\pm [1% of control + 1 mV (V _{pp})] at 1 kHz
DC offset range	sine, square/pulse, ramp, pulse,	, exponential rise, exponential fall
	into 50 Ω	$\pm [3 \text{ V} - (\text{amplitude [V (V_{pp})]} / 2)]$
	into open circuit	± [6 V – (amplitude [V (Vpp)] / 2)]
	sine cardinal (sinc), Gauss, Lorentz	
	into 50 Ω	±0.5 V
	into open circuit	±1 V
	resolution	1 mV
	accuracy	± (2 % of control + 2 mV)
Frequency accuracy		$ \Delta f \le [\text{(timebase accuracy)} \times (\text{nominal})$
		frequency) + 1 µHz]
		(timebase accuracy: see Horizontal
		system)

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 $^{^{\}rm 7}$ $\,$ Amplitude is the sum of the AC amplitude and the noise amplitude.

8-bit pattern generator

Function	output of user-defined patterns
Output channels	8 channels, coupled w.r.t. pattern length
	and data output rate
Pattern length	1 bit to 40 Mbit on each channel
Bit rate	1 bit/s to 40 Mbit/s

Outputs		
Connector		16-pin double row connector, 2.54 mm pitch, located on an adapter board, which is connected via a removable ribbon cable to the R&S®RTO-B6
Output impedance		nom. 330 Ω
Overload protection	reverse input voltage without damage	-0.5 V to +6.5 V (meas.), ESD protection
Amplitude	low level output voltage (I = 100 μA)	
	output voltage	0 V + 0.15 V/- 0.02 V
	accuracy	≤ 0.15 V (meas.)
	high level output voltage	
	setting range	1.2 V to 5.0 V
	resolution	0.1 V
	accuracy	≤ 0.05 V
Rise/fall time		8 ns (meas.)
Overshoot		≤ 5 % (meas.)

R&S®RTO-B7 16 GHz differential pulse source

16 GHz differential pulse source with reference output

Output 8

Output pulse		two complementary negative going square wave pulse train signals, single-ended or differential operation, fast transition on rising and falling edge, adjustable amplitude and timing parameters, free-running or phase-locked to base unit
Outputs	single-ended operation	single-ended output (OutP)
		single-ended reference output (RefP)
	differential operation	differential output (OutP, OutN)
		differential reference output (RefP, RefN)
Output connectors		SMA female connectors
Reverse DC voltage		0 V
Output impedance	single-ended outputs	nom. 50 Ω
	both differential pairs	nom. 100 Ω
Return loss	≤ 10 GHz	> 15 dB (meas.)
	≤ 20 GHz	> 12 dB (meas.)

DC characteristics 8

⁸ All four outputs terminated with 50 Ω; all parameters are measured at all four single-ended outputs, unless noted.

Time domain characteristics 8

Transition time	10 % to 90 %, rising and falling edge, calcu	ulated from 0.36/bandwidth
	output low level: -120 mV to -50 mV	20 ps
	output low level: -200 mV to -130 mV	22 ps
Step response aberrations	for the first 100 ps after step transition	±10 % (meas.)
	for the first 1 ns after step transition	±4 % (meas.)
	until 100 ps before following step	±2 % (meas.)
	transition	
Repetition rate	low frequency mode	5 Hz, 10 Hz, 20 Hz, 50 Hz, 100 Hz,
		200 Hz, 500 Hz to 1 MHz
	high frequency mode, phase-locked to	5 MHz, 10 MHz, 25 MHz, 50 MHz,
	base unit	100 MHz, 250 MHz
	high frequency mode, free-running	5 MHz, 10 MHz, 25 MHz, 50 MHz
Positive duty cycle	measured at 50 % of transition	
	low frequency mode	10 % to 90 %, adjustable in 10 % steps
	high frequency mode	50 %
Duty cycle error	measured at 50 % of transition, at OutP and RefP outputs	
	low frequency mode	±2 % (meas.)
	high frequency mode	±0.1 % (meas.)
Skew	measured at 50 % of transition,	< 0.5 ps (meas.)
	between OutP and OutN output	
Clock accuracy	free-running	±100 ppm (meas.)
-	phase-locked to base unit	see Timebase accuracy of base unit

Frequency domain characteristics 8

Analog bandwidth (-3 dB)	output low level: -120 mV to -50 mV	> 18 GHz (meas.)
	output low level: -200 mV to -130 mV	> 16.5 GHz (meas.)
Spectral magnitude error to ideal step	≤ 5 GHz	+0.5 dB to -1 dB (meas.)
spectrum	≤ 12 GHz	+0.5 dB to -2 dB (meas.)
	≤ analog bandwidth	+0.0 dB to -3 dB (meas.)

R&S®RTO-B10 additional GPIB interface

Function	interface in line with IEC 625-2
	(IEEE 488.2)
Command set	SCPI 1999.0
Connector	24-pin Amphenol female
Interface functions	SH1, AH1, T6, L4, SR1, RL1, PP1, DC1,
	DT1, C0

R&S®RTO-B19 additional solid state disk

Disk type	solid state disk
Disk size	nom. ≥ 240 Gbyte
Firmware	installed upon delivery

R&S®RTO-K1 I²C/SPI serial triggering and decoding

I ² C serial triggering and decodi	ing	
Protocol configuration	bit rate	auto-detected
	auto threshold setup	assisted threshold configuration for I ² C triggering and decoding
	device list	associate frame address with symbolic ID
Trigger	source (clock and data)	any input channel or logical channel
	bit rate	up to 6.5 Mbps
	trigger event setup	start, stop, restart, missing ACK, address, data, address + data
	address setup	7 bit or 10 bit address (value in hex, decimal, octal or binary); ACK, NACK or either; read, write or either; R/W bit included in address value or apart; condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); condition $=$, \neq , \geq , \leq , in range, out of range; offset within frame in range from 0 byte to 4095 byte
Decode	source (clock and data)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	frame, start/restart, address, R/W bit, data, ACK/NACK, stop, error
	address and data format	hex, decimal, octal, binary, ASCII; symbolic names for user-defined subset of addresses
	decode layer	off, edges, bit
Search	search event setup	combination of start, stop, restart, missing ACK, address, data, address + data
	event settings	same as trigger event settings

SPI serial triggering and decod	ing	
Protocol configuration	type	2-wire, 3-wire and 4-wire SPI
	bit rate	auto-detected
	bit order	LSB first, MSB first
	word size	4 bit to 32 bit
	frame condition	SS, timeout
	polarity (MOSI, MISO, SS, CLK)	active high, active low
	phase (CLK)	first edge, second edge
	auto threshold setup	assisted threshold configuration for SPI triggering and decoding
Trigger	source (MOSI, MISO, SS, CLK)	any input channel or logical channel
	bit rate	up to 50 Mbps
	trigger event setup	start of frame, MOSI, MISO, MOSI + MISO
	data setup	data pattern up to 256 bit (hex or binary);
		condition =, ≠; offset within frame in range from 0 bit to 32767 bit
Decode	source (MOSI, MISO, SS, CLK)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	frame, word, error
	data format	hex, decimal, octal, binary, ASCII
	decode layer	edges, bits, words
Search	search event setup	start of frame, MOSI, MISO, MOSI + MISO
	event settings	same as trigger event settings

R&S®RTO-K2 UART/RS-232/RS-422/RS-485 serial triggering and decoding

Protocol configuration	bit rate	300 bps to 20 Mbps
	signal polarity	idle low, idle high
	number of bits	5 bit to 9 bit
	bit order	LSB first, MSB first
	parity	odd, even, mark, space, none
	stop bit	1, 1.5 or 2 bit periods
	end of packet	word, timeout, none
	auto threshold setup	assisted threshold configuration for
		UART triggering and decoding
Trigger	source (TX and RX)	any input channel or logical channel
	trigger event setup	start bit, packet start, data, parity error, break condition
	data setup	data pattern up to 256 bit (hex, decimal, octal, binary or ASCII); condition =, ≠; offset within packet in range 0 bit to 32767 bit
Decode	source (TX and RX)	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	packet, data payload, start error, parity error, stop error
	data format	hex, decimal, octal, binary, ASCII

R&S®RTO-K3 CAN/LIN serial triggering and decoding

		•
CAN serial triggering and deco	ding	
Protocol configuration	signal type	CAN_H, CAN_L
•	bit rate	100 bps to 1 Mbps
	sampling point	5 % to 95 % within bit period
	device list	associate frame identifier with symbolic ID, load DBC file content
	auto threshold setup	assisted threshold configuration for CAN triggering and decoding
Trigger	source	any input channel or logical channel
Thiggs.	trigger event setup	start of frame, frame type, identifier, identifier + data, symbolic, error condition (any combination of CRC error, bit stuffing error, form error and ACK error)
	identifier setup	frame type (data, remote or both), identifier type (standard or extended); condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 8 byte (hex, decimal, octal or binary); big-endian or little-endian; condition $=$, \neq , \geq , \leq , in range, out of range
	symbolic setup	message name, signal name; numeric signal condition =, \neq , \geq , \leq , in range, out of range; enumerated signal condition =, \neq , \geq , \leq
Decode	source	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	start of frame, identifier, DLC, data payload, CRC, end of frame, error frame, overload frame, CRC error, bit stuffing error
	data format	hex, decimal, octal, binary, ASCII, symbolic

Search	source	any input channel or logical channel
	search event setup	combination of start of frame, frame type,
		identifier, identifier + data, error condition
		(any combination of CRC error, bit stuffing
		error, form error and ACK error) or only
		symbolic
	event settings	same as trigger event settings

LIN serial triggering and decode Protocol configuration	version	1.3, 2.x or SAE J602; mixed traffic is
T Totogor cormiguration	Volcion	supported
	bit rate	standard bit rate (1.2/2.4/4.8/9.6/10.417/
		19.2 kbps) or user-defined bit rate in range
		from 1 kbps to 20 kbps
	device list	associate frame identifier with symbolic ID,
		data length and protocol version
	auto threshold setup	assisted threshold configuration for LIN
		triggering and decoding
Trigger	source	any input channel
	trigger event setup	start of frame (sync break), identifier,
		identifier + data, wake-up frame, error
		condition (any combination of checksum
		error, parity error and sync field error)
	identifier setup	range from 0d to 63d; select condition =,
		≠, ≥, ≤, in range, out of range for trigger
		"identifier"; select single identifier and
		condition = for trigger "identifier + data"
	data setup	data pattern up to 8 byte (hex, decimal,
		octal or binary); condition =, \neq , \geq , \leq , in
		range, out of range
Decode	source (TX and RX)	any input channel, math waveform,
		reference waveform
	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list
	color coding	frame, frame identifier, data payload,
		checksum, error condition
	data format	hex, decimal, octal, binary, ASCII
Search	search event setup	combination of start of frame (sync break),
		identifier, identifier + data, wake-up frame,
		error condition (any combination of
		checksum error, parity error and sync field
		error)
	event settings	same as trigger event settings

R&S®RTO-K4 FlexRay™ serial triggering and decoding

		•
Protocol configuration	signal type	single-ended, differential, logic
	channel type	channel A, channel B
	bit rate	standard bit rates (2.5/5.0/10.0 Mbps)
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration for
		FlexRay™ triggering and decoding
	source	any input channel or logical channel
Trigger	trigger event setup	start of frame, header + data, symbol,
		wake-up, error condition (any combination
		of FSS error, BSS error, FES error, header
		CRC error and frame CRC error)
	header setup	indicator bits, identifier, payload length, cycle count
	indicator bits setup	payload preamble bit, null frame bit, sync
	indicator bits setup	frame bit and startup frame bit separately
		configurable (1, 0 or don't care)
	identifier setup	condition =, \neq , \geq , \leq , in range, out of range
	payload length setup	condition =, \neq , \geq , in range, out of range
	cycle count	condition =, \neq , \geq , in range, out of range;
	oyolo coulit	step parameter for selection of non-
		contiguous values within provided range
	data setup	data pattern up to 8 byte (hex, decimal,
	1	octal or binary); condition =, \neq , \geq , \leq , in
		range, out of range; offset within frame in
		range from 0 byte to 253 byte
Decode	source	any input channel, math waveform,
		reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical
	' ' ' '	signal, tabulated list
	color coding	frame, frame header, identifier, payload
		length, header CRC, cycle count, data
		payload, frame CRC, error condition
	data format	hex, decimal, octal, binary, ASCII
Search	search event setup	combination of start of frame, header +
		data, symbol, wake-up, error condition
		(any combination of FSS error, BSS error,
		FES error, header CRC error and frame
		CRC error)
	event settings	same as trigger event settings

R&S®RTO-K5 I2S serial triggering and decoding

Protocol configuration	signal type	I ² S standard, left justified, right justified, TDM
	auto threshold setup	assisted threshold configuration for I2S triggering and decoding
Trigger	source	any input channel or logical channel
55	trigger event setup	data, window, frame condition, word select, error condition
	data setup	data pattern of an audio channel up to 4 byte (hex, signed decimal, unsigned decimal, octal or binary); condition =, \neq , \geq , \leq , $<$, $>$, in range, out of range
	window setup	word count of data pattern of an audio channel up to 4 byte (hex, signed decimal, unsigned decimal, octal or binary); condition $=$, \neq , \geq , \leq , $<$, $>$, in range, out of range
	frame condition setup	combination of audio channels in a frame, up to 4 byte (hex, signed decimal, unsigned decimal, octal or binary); condition $=$, \neq , \geq , \leq , $<$, $>$, in range, out of range
	word select setup	rising or falling edge of word select input channel
	error condition setup	source of word select
Decode	source	any input channel, math waveform, reference waveform, logical channel
	display type	decoded bus, logical signal, bus and logical signal, tabulated list
	color coding	audio frame, frame error, incomplete frame
	data format	hex, unsigned decimal, signed decimal (two's complement), octal, binary, ASCII
Protocol measurements	audio display	display of audio waveform for specified audio channels
	long-term display	history of selected audio data as trace against measurements, waveforms and time index

R&S®RTO-K6 MIL-STD-1553 serial triggering and decoding

Protocol configuration	signal type	single-ended
	bit rate	standard bit rate (1 Mbit/s)
	polarity	normal, inverted
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	min. gap (2 µs to 262 µs) or off;
		max. response (2 µs to 262 µs) or off
Trigger	trigger event setup	sync, word, data word, command/status
		word, command word, status word, error
		condition
	sync and word setup	all words, command/status word,
		data word
	data word setup	RTA (condition =, \neq , \geq , in range, out of
		range); data pattern (condition =, \neq , \geq , \leq , ir
		range, out of range); payload data index
		$(=, <, >, \ge, \le, range)$; max length of data
		pattern is 4 byte
	command/status word setup	RTA (condition =, \neq , \geq , \leq , in range, out of
		range); 11 bit pattern (condition =, \neq , \geq , \leq ,
		in range, out of range)
	command word setup	RTA (condition =, \neq , \geq , \leq , in range, out of
		range); subaddress/mode (condition =, ≠,
		≥, ≤, in range, out of range); data word
		count/mode count (condition =, \neq , \geq , \leq , in
	atatua ward	range, out of range); direction (T/R)
	status word	RTA (condition =, \neq , \geq , \leq , in range, out of
		range); status flags (message error, instrumentation, service request,
		broadcast command, busy, subsystem
		flag, dynamic bus control, terminal flag)
	error condition	any combination of sync error, Manchester
	Citor condition	error, parity error, timing error (see
		protocol configuration)
Decode	source	any analog input channel, math waveform,
Decode	004100	reference waveform
	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list
	color coding	frame (word), sync, RTA, status bit field,
		parity, data field, error condition
	data format	hex, octal, binary, ASCII, signed, unsigned
Search	search event setup	sync, word, data word, command/status
	·	word, command word, status word, error
		condition
	event settings	same as trigger event settings

R&S®RTO-K7 ARINC 429 serial triggering and decoding

Protocol configuration	signal type	single-ended
	bit rate	high (100 kbit/s)
		low (12 kbit/s to 14.5 kbit/s)
	polarity	A leg, B leg
	device list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	min. gap (0 bit to 100 bit) or off;
		max. gap (0 bit to 1000 bit) or off
Trigger	trigger event setup	word start, word stop, label + data, error condition
	label + data setup	label (condition =, \neq , \geq , \leq , in range, out of range); data (condition =, \neq , \geq , \leq , in range, out of range); SDI/SSM
	error condition	any combination of coding error, parity error, timing error (see protocol configuration)
Decode	source	any analog input channel, math waveform, reference waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	frame (word), label, SDI, data, SSM, parity, error condition
	data format	hex, octal, binary, ASCII, signed, unsigned
Search	search event setup	word start, word stop, label + data, error condition
	event settings	same as trigger event settings

R&S®RTO-K8 Ethernet (10BASE-T/100BASE-TX) serial triggering and decoding

Protocol configuration	signal type	one differential channel
	bit rate	auto-detected
	auto threshold setup	assisted threshold configuration
	full autoset	adjust horizontal and vertical resolution and perform auto threshold
	source (SDATA)	analog and math channels
	variants	10BASE-T, 100BASE-TX
Trigger	frame start	trigger at start of any MAC frame
	pattern	fast trigger for 10BASE-T MAC frames, 32 byte, index 0 to 65535
	frame	advanced trigger configuration for MAC frames only
		48 bit destination address, 48 bit source
		address, 16 bit length/type, 32 bit frame check; conditions =, \neq , <, \leq , >, \geq , in range,
		out of range
	error	preamble error, length error, CRC error
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, details, decode layers
	color coding	preamble, frame, destination address, source address, data
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, binary
	result export	export of all result data into CSV, XML, HTM and PY file formats
Search	search event setup	frame, error
	event settings	same as trigger event settings

R&S®RTO-K9 CAN-FD serial triggering and decoding

Protocol configuration	signal type	CAN_H, CAN_L
	standard	ISO, non-ISO (Bosch)
	bit rate	
	arbitration rate	10 kbps to 1 Mbps
	data rate	10 kbps to 15 Mbps
	sampling point	5 % to 95 % within bit period; independent
		settings for arbitration phase and data
		phase
	device list	associate frame identifier with symbolic ID,
		load DBC file content
	auto threshold setup	assisted threshold configuration
Trigger	source	any input channel or logical channel
	trigger event setup	start of frame, frame type, identifier,
		identifier + data, symbolic, error condition
		(any combination of CRC error, bit stuffing
		error, form error and ACK error)
	identifier setup	frame type (data, remote or both),
		identifier type (standard or extended);
		condition =, ≠, ≥, ≤, in range, out of range
	FD bits	FDF, BRS and ESI (0, 1, X)
	data setup	data pattern up to 8 byte in the complete
		data range (hex, decimal, octal or binary);
		condition =, \neq , \geq , \leq , in range, out of range
	symbolic setup	message name, signal name;
		numeric signal condition =, \neq , \geq , in
		range, out of range;
		enumerated signal condition =, ≠, ≥, ≤
Decode	source	any input channel, math waveform,
		reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	start of frame, identifier, FD bits, DLC,
	color county	data payload, CRC, end of frame, error
		frame, overload frame, CRC error, bit
		stuffing error
	data format	hex, decimal, octal, binary, ASCII,
	data format	symbolic
	supported data length	64
Search	source	any input channel or logical channel
	search event setup	combination of start of frame, frame type,
	search event setup	identifier, identifier + data, error condition
		(any combination of CRC error, bit stuffing
		error, form error and ACK error) or only
		symbolic
	event settings	same as trigger event settings
		came as mage. Of one country

R&S®RTO-K10 SENT serial triggering and decoding

Protocol configuration	signal type	data signal
	clock period (clock tick)	1 µs to 100 µs
	clock tolerance	0 % to 25 %
	data nibbles	1 to 6
	serial message type	none, short serial message and enhanced
		serial message
	CRC version	Legacy (Feb 2008) and v2010 (Latest)
	CRC calculation	SAE J2716 standard and TLE 4998X
	pause pulse	no, yes, for constant frame length
	frame length in clock ticks (applicable only	104 to 922
	when pause pulse = constant frame	10110022
	length)	
Trigger	source	any analog input channel
riiggei	trigger event setup	calibration or sync, transmission
	trigger event setup	-
		sequence, serial message and
	tronomicaion aggregas status nibile setura	error condition
	transmission sequence status nibble setup	from 0 to F, condition =, \neq , \geq , \leq , in range,
		out of range
	transmission sequence data nibbles setup	each nibble value from 0 to F, condition =,
		≠, ≥, ≤, in range, out of range
	serial message identifier setup	from 00 to FF, condition =, \neq , \geq , \leq , in
		range, out of range
	serial message identifier type setup	4 bit and 8 bit
	(applicable only when the serial protocol =	
	enhanced serial message in protocol	
	configuration)	
	serial message data setup	00 to FF (short serial message)
		000 to FFF (enhanced serial message with
		8 bit ID)
		0000 to FFFF (enhanced serial message
		with 4 bit ID)
	error condition setup	form error, calibration pulse error, pulse
	·	period error, CRC error and irregular
		frame length error
Decode	source	any analog input channel,
	display type	decoded bus, tabulated list
	color coding	transmission sequence:
	55.57 55ag	sync/calibration, status, data bits, CRC,
		pause pulse (optional), calibration pulse
		error, pulse period error, irregular frame
		length error and CRC error;
		serial message:
		identifier, data, CRC, form error, CRC
		error
	data format	
Search		hex, decimal, octal, binary, ASCII
Search	source	any analog input channel
	search event setup	calibration or sync, transmission
		sequence, serial message and
		error condition
	event settings	same as trigger event settings

R&S®RTO-K11 I/Q software interface

General	function			ation and recording of RF or	
	input signals (2 shappel models)		baseband signals as I/Q samples		
	input signals (2 channel models)		two real RF signals or		
	input signals (4 channel models)		one complex I/Q signal four real RF signals or		
	input signais (4 channe	i models)	two complex I/Q signal	o or	
			two real RF signals and		
				one complex I/Q signal between 100 Hz and 5 GHz (or mixer deactivated)	
	mixer frequency				
	sampling rate of record	ed I/O samples	between 1 ksample/s a	, ,	
		flat frequency response)	4 % to 80 % of sampling	l l	
	sampling rate of record		between 1 ksample/s and 10 Gsample/s user-		
	sampling rate of record	od i/ & ddiripidd	selectable		
	recording length		recording length indep	endent of sampling rate	
	standard			one or two input signals,	
			•	hree or four input signals	
	R&S®RTO-B110 option	on		one or two input signals,	
			-	three or four input signals	
Trigger	mode		auto or normal		
33 -	operation			gnal after A/D conversion	
	•		serial bus and MSO tri		
	additional modes		NFC-A, 106 kbps, SEN		
			NFC-B, 106 kbps, SEN		
				4 kbps, start of sequence	
			(SoS) length: 48 bit or	96 bit	
Display			magnitude of the down	converted signals	
Amplitude flatness with	R&S®RTO2002 and	max. used center	with I/Q bandwidth	with I/Q bandwidth	
RF signal input (meas.)	R&S®RTO2004	frequency	100 MHz	250 MHz	
,		≤ 100 MHz	±0.10 dB		
		≤ 200 MHz	±0.12 dB	±0.30 dB	
		≤ 300 MHz	±0.20 dB	±0.50 dB	
		≤ 400 MHz	±0.25 dB	±0.70 dB	
		≤ 500 MHz	±0.35 dB	±1.00 dB	
	R&S®RTO2012 and	max. used center	with I/Q bandwidth	with I/Q bandwidth	
	R&S®RTO2014	frequency	100 MHz	250 MHz	
		≤ 100 MHz	±0.10 dB		
		≤ 200 MHz	±0.10 dB	±0.15 dB	
		≤ 500 MHz	±0.10 dB	±0.25 dB	
		≤ 750 MHz	±0.15 dB	±0.40 dB	
		≤ 1 GHz	±0.30 dB	±0.90 dB	
	R&S®RTO2022 and	max. used center	with I/Q bandwidth	with I/Q bandwidth	
	R&S®RTO2024	frequency	100 MHz	500 MHz	
		≤ 100 MHz	±0.10 dB		
		≤ 500 MHz	±0.10 dB	±0.10 dB	
		≤ 1 GHz	±0.17 dB	±0.35 dB	
		≤ 1.5 GHz	±0.20 dB	±0.50 dB	
		≤ 2 GHz	±0.35 dB	±1.00 dB	
	R&S®RTO2032 and	max. used center	with I/Q bandwidth	with I/Q bandwidth	
	R&S®RTO2034	frequency	100 MHz	500 MHz	
		≤ 100 MHz	±0.10 dB		
		≤ 500 MHz	±0.10 dB	±0.10 dB	
		≤ 1 GHz	±0.10 dB	±0.35 dB	
		≤ 2 GHz	±0.10 dB	±0.35 dB	
		≤ 3 GHz	±0.30 dB	±1.30 dB	
	R&S®RTO2044	max. used center	with I/Q bandwidth	with I/Q bandwidth	
		frequency	100 MHz	500 MHz	
		≤ 100 MHz	±0.10 dB		
		≤ 500 MHz	±0.10 dB	±0.10 dB	
		≤ 1 GHz	±0.10 dB	±0.10 dB	
		≤ 2 GHz	±0.10 dB	±0.15 dB	
		≤ 3 GHz	±0.12 dB	±0.30 dB	
	≤ 4 GHz				

R&S®RTO-K12 jitter analysis

General description		option extends the functionality of the standard		
	R&S®RTO firmware with a suite of measurement, analysis and visualization tools for signal integrity analysis and jitter characterization.			
Waveform measurements	category			
	measurement functions	cycle-to-cycle jitter, N-cycle jitter, cycle-to-cycle width, cycle-to-cycle duty cycle, time-interval error, data rate, unit interval, skew delay, skew phase; the standard time measurements period, frequency and setup/hold are also available in the jitter category for convenience		
	track	measurement results displayed as continuous trace that is time-correlated to the measurement source; applicable to time measurements from categories "jitter" and "amplitude and time"; track trace may be used as source for cursor measurements, automatic measurements, math waveforms and reference waveforms		
Waveform math	FFT on track	FFT spectrum of the track trace of measurement results		
	CDR transform	recovers clock timing from source waveform with software CDR and generates synthetic clock waveform that is time-correlated to source		
Software clock data recovery (CDR)	number of CDR instances	up to 2; independently configurable		
,	algorithm	phase-locked loop (PLL), constant frequency		
	configuration	nominal bit rate, PLL order (first or second), PLL loop bandwidth, PLL damping factor, initial phase alignment, result selection during initial synchronization		
Mask testing with eye mask assistant	primary mask shape			
	type	diamond, square, hexagon, octagon		
	dimensions	main and secondary height, main and secondary width, depending on selected shape		
	position	vertical offset, horizontal offset		
	secondary mask shapes			
	locations	any combination of left, right, top, bottom		
	position	horizontal and vertical offset with respect to center of primary mask shape		

R&S®RTO-K13 clock data recovery

General description	The R&S®RTO-K13 realtime clock data recovery (CDR) option activates the hardware CDR circuitry integrated into the R&S®RTO oscilloscope. It provides realtime clock recovery for non-return-to-zero (NRZ) serial data up to 5.0 Gbps. The recovered clock may be used for triggering and jitter analysis.	
Hardware clock data recovery (CDR)	description	fully digital implementation of PLL-based clock data recovery
	sources	•
	R&S®RTO2002, R&S®RTO2012, R&S®RTO2022, R&S®RTO2032	channel 1, channel 2
	R&S®RTO2004, R&S®RTO2014, R&S®RTO2024, R&S®RTO2034, R&S®RTO2044	channel 1, channel 2, channel 3, channel 4
	configuration parameters	PLL order (first or second), nominal bit rate, loop bandwidth, relative bandwidth, damping factor, unit interval offset
	bit rate range	,
	R&S®RTO2002, R&S®RTO2004, R&S®RTO2012, R&S®RTO2014, R&S®RTO2022, R&S®RTO2024, R&S®RTO2032, R&S®RTO2034	200 kbps to 2.5 Gbps
	R&S®RTO2044	200 kbps to 2.5 Gpbs standard, 400 kbps to 5.0 Gbps when operating at 20 Gsample/s realtime sampling rate ⁹
	R&S®RTO2064	400 kbps to 5.0 Gbps standard, 200 kbps to 2.5 Gpbs when operating at 10 Gsample/s realtime sampling rate ¹⁰
	relative bandwidth	1/500 to 1/3000 of the nominal bit rate
	damping factor	0.5 to 1.0; relevant for second order PLL only
	unit interval offset	0.0 to 1.0
Trigger modes	CDR	triggers on clock signal recovered from the trigger source signal; phase of the trigger instant user-selectable as fraction of bit period
	serial pattern	main trigger mode "serial pattern" supports the hardware CDR as additional clock source; sampling point user-selectable as fraction of bit period
Jitter analysis	The data and clock timing information of the hardware CDR may be acquired in realtime concurrently to the input data waveform. Analysis of the realtime CDR timing information is possible by means of compatible measurement, analysis and visualization tools provided in the R&S®RTO-K12 jitter analysis option. ¹¹	
	measurement functions	time-interval error (TIE), data rate, unit interval
	math functions	CDR transform interprets the acquired clock timing information and generates a synthetic clock waveform that is time-correlated to the input data waveform

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⁹ In general terms, the frontend of the R&S®RTO2044 samples at 20 Gsample/s when: at most one channel from each pair {channel1, channel2} and {channel3, channel4} is active; and the user-selected sampling resolution in realtime sampling mode or interpolated time sampling mode is 50 ps or smaller.

¹⁰ In general terms, the frontend of the R&S®RTO2064 samples at 20 Gsample/s when at most one channel from each pair {channel1, channel2} and {channel3, channel4} is active, otherwise the sampling rate is 10 Gsample/s.

¹¹ Realtime CDR timing information can be acquired when the frontend is operating at 10 Gsample/s realtime sampling rate.

R&S®RTO-K18 spectrum analysis

General description	The R&S [®] RTO-K18 spectrum ana frequency domain.	lysis allows advanced signal analysis in the
Spectrogram	display characteristics	spectrogram display; a separate spectrogram can be created for each FFT display; each FFT segment of a captured acquisition is displayed in a separate spectrogram line
		support of logarithmic frequency x-axis
	number of spectrograms	up to 4
	signal colors	predefined or user-defined color tables for persistence display with the spectrogram
	time lines	in stop mode two separate time lines can be used to navigate through a spectrogram in time; for each time line the relevant FFT segment is displayed in a diagram; the difference in acquisition time between the timelines is displayed
Logarithmic frequency x-axis	display characteristics	logarithmic frequency x-axis for the FFT display with support of analysis tools like cursors and masks
		logarithmic frequency x-axis for the spectrogram display
Waveform measurements	measurement functions	total harmonic distortion variants THD _a , THD _a and THD _r using voltage, overall voltage and overall voltage root means square
	peak list	peak list; diagram labels for easy identification of the peak list entries in the diagram
Waveform math		user-selectable max. hold and min. hold in addition to spectrum averaging, RMS and envelope

R&S®RTO-K19 zone trigger

General description	The R&S®RTO-K19 zone trigger	The R&S®RTO-K19 zone trigger enables the triggering on user-defined zones drawn on	
	the display.		
Source		acquired waveforms (input channels), math waveforms	
Zone definition	number of zones	up to 8	
	shapes	rectangles, polygones	
	types	must intersect, must not intersect	
	combination of zones	logical combination of zones of multiple sources using Boolean expressions	
Trigger compatibility		compatible with the trigger modes edge, glitch, width, runt, window, timeout, interval, slew rate, data2clock, pattern, state, serial pattern, trigger qualification, and sequence trigger	

R&S®RTO-K21 USB 2.0 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K21 performs USB 2.0 compliance test measurements with R&S®ScopeSuite, including tests for USB 2.0 (high speed), USB 1.1 (full speed) and USB 1.0 (low speed) with the R&S®RTO. R&S®ScopeSuite supports the R&S®RT-ZF1 USB 2.0 compliance test fixture set and the Allion USB test fixture solutions and the USB-IF signal quality board device/host; R&S®ScopeSuite supports Windows 7, 8 and 10.

USB device test	high speed	signal quality (EL_2, 4, 5, 6, 7); packet
002 401100 1001	Tilgi opeda	parameters (EL_21, 22, 25); chirp timing (EL_28, 29, 31); suspend/resume/reset timing (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK (EL_8, 9); receiver sensitivity
	full speed and low speed	(EL_16, 17, 18) full speed signal quality; back voltage; inrush current
USB host test	high speed	signal quality (EL_2, 3, 6, 7); packet parameters (EL_21, 22, 23, 25, 55); chirp timing (EL_33, 34, 35); suspend/resume/reset timing (EL_39, 41); test J/K, SE0_NAK (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality downstream; drop droop
USB hub test	high speed	signal quality upstream (EL_2, 4, 6, 7); signal quality downstream (EL_2, 3, 6, 7); jitter downstream (EL_47); packet parameters upstream (EL_21, 22, 25); hub receiver sensitivity upstream (EL_16, 17, 18); repeater downstream (EL_42, 43, 44, 45, 48); repeater upstream (EL_42, 43, 44, 45); chirp timing upstream (EL_28, 29, 31); suspend/resume/reset timing upstream (EL_27, 28, 38, 39, 40); test J/K, SE0_NAK upstream (EL_8, 9); test J/K, SE0_NAK downstream (EL_8, 9)
	full speed and low speed	low speed signal quality downstream; full speed signal quality upstream; full speed signal quality downstream; inrush current upstream; drop downstream; droop downstream;

R&S®RTO-K22 Ethernet compliance test (10/100/1000BASE-T/EEE)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K22 performs Ethernet compliance test measurements with R&S®ScopeSuite, including tests for 10BASE-T, 100BASE-TX,1000BASE-T and Energy Efficient Ethernet (EEE) with the R&S®RTO. R&S®ScopeSuite supports the R&S®RT-ZF2 Ethernet compliance test fixture set as well as the R&S®RT-ZF4 and R&S®RT-ZF5 for EEE; R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported Ethernet 10G con	npliance tests	
Standard reference		IEEE 802.3-2012
1000BASE-T	with/without disturber	with/without TX_CLK transmitter distortion (40.6.1.2.4)
		peak differential output voltage (40.6.1.2.1)
		maximum output droop (40.6.1.2.2)
	=	differential output templates (40.6.1.2.3)
	with TX_CLK	jitter master mode (40.6.1.2.5), jitter slave mode (40.6.1.2.5)
	without TX_CLK	jitter master mode (40.6.1.2.5)
	common	MDI return loss (40.8.3.1), common-mode output voltage (40.8.3.3)
100BASE-TX		amplitude domain tests
TOOD/TOE T/X		(9.1.2.2, 9.1.3 and 9.1.4)
		rise and fall times (9.1.6)
		peak to peak duty cycle distortion (9.1.8)
		peak to peak transmitter jitter (9.1.9)
		active output interface template (annex J)
		transmitter return loss (9.1.5)
		receiver return loss (9.2.2)
10BASE-T	no TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		peak differential voltage (14.3.1.2.1)
		harmonic content (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	with TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		MAU template (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	common	transmitter return loss (14.3.1.2.2),
		receiver return loss (14.3.1.3.4)
		common-mode output voltage (14.3.1.2.5)

Supported EEE compliance tests	
Standard reference	IEEE 802.3-2012
1000BASE-T EEE	quiet time (78.2)
(requires R&S®RT-ZF5)	refresh time (master) (78.2)
	refresh time (slave) (78.2)
	wake state levels (40.6.1.2.7)
	transmitter timing jitter with TX_TCLK (master) (40.6.1.2.5)
	transmitter timing jitter with TX_TCLK (slave) (40.6.1.2.5)
	transmitter timing jitter without TX_TCLK (master) (40.6.1.2.5)
	transmitter timing jitter without TX_TCLK (master) (40.6.1.2.5)
100BASE-TX EEE	sleep time (24.2.3.4 and 78.2)
(requires R&S®RT-ZF5)	LPI quiet time (24.2.3.4 and 78.2)
	LPI refresh time (24.2.3.4 and 78.2)
	LPI transmitter timing jitter (24.2.3.4 and
	78.2)
	transmit wake time (24.2.3.4 and 78.2)

10BASE-Te	no TPM	link test pulse template (14.3.1.2.1)
(requires R&S®RT-ZF4)		TP_IDL template (14.3.1.2.1)
		peak differential voltage (14.3.1.2.1)
		harmonic content (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	with TPM	link test pulse template (14.3.1.2.1)
		TP_IDL template (14.3.1.2.1)
		MAU template (14.3.1.2.1)
		output timing jitter (14.3.1.2.3)
	common	transmitter return loss (14.3.1.2.2),
		receiver return loss (14.3.1.3.4)
		common mode output voltage
		(14.3.1.2.5)

R&S®RTO-K23 Ethernet compliance test (2.5/5/10GBASE-T)

The R&S®RTO-K23 option is available for R&S®RTO2022, R&S®RTO2024, R&S®RTO2032, R&S®RTO2034 and R&S®RTO2044 models only. The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K23 performs Ethernet compliance test measurements with R&S®ScopeSuite, including tests for 2.5GBASE-T, 5GBASE-T and 10GBASE-T with the R&S®RTO. R&S®ScopeSuite supports the R&S®RT-ZF2 Ethernet compliance test fixture set; R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported Ethernet compliance tests	
Standard reference	IEEE 802.3-2012 and IEEE P802.3bz
2.5G/5GBASE-T	maximum output droop (126.5.3.1)
	transmitter nonlinear distortion
	(126.5.3.2)
	transmitter timing jitter master mode and
	clock frequency (126.5.3.3 and 126.5.3.5)
	transmitter timing jitter slave mode (126.5.3.3)
	transmitter power spectral density and
	power level (126.5.3.4)
	MDI return loss (126.6.2.1)
10GBASE-T	maximum output droop (55.5.3.1)
	transmitter linearity (55.5.3.2)
	transmitter timing jitter master mode
	(55.5.3.3)
	transmitter timing jitter slave mode
	(55.5.3.3)
	transmitter power spectral density
	(55.5.3.4) ¹²
	transmitter power level (55.5.3.4) 12
	transmitter clock frequency (55.5.3.5)
	MDI return loss (55.8.2.1)

¹² Requires an oscilloscope model with a bandwidth higher than or equal 3 GHz.

R&S®RTO-K24 Ethernet compliance test (100BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K24 performs 100BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF2, R&S®RT-ZF7A and R&S®RT-ZF8 Ethernet compliance test fixtures. The chapters after the test cases refer to IEEE 802.3-2018 and OPEN Alliance ECU specification version 2.0.

Supported 100BASE-T1 compliance tests	
100BASE-T1	transmitter output droop (96.5.4.1)
	transmitter distortion with and without
	disturber (96.5.4.2)
	transmitter timing jitter master mode
	(96.5.4.3)
	transmitter timing jitter slave mode
	(96.5.4.3)
	transmitter power spectral density
	(96.5.4.4)
	transmitter clock frequency (96.5.4.5)
	transmitter peak differential output
	(96.5.6)
	MDI return loss (96.7.1.3)
	MDI mode conversion Loss (96.8.2.2)
	MDI mode conversion Loss Adapter
	Verification (OABR_PMA_TX_06)
	MDI Common Mode Emission
	(OABR_PMA_TX_07)

R&S®RTO-K26 MIPI D-PHY compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K26 performs D-PHY compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10. The numbers behind the test refer to the MIPI CTS for D-PHY V1.1.

Supported D-PHY compli D-PHY	group 1 (7 tests): data lane LP-TX	data lane LP-TX Thevenin output high
	signaling requirements	level voltage (V _{OH}) – 1.1.1
		data lane LP-TX Thevenin output low
		level voltage (V _{OL}) – 1.1.2
		data lane LP-TX from 15 % to
		85 % rise time (T _{RLP}) – 1.1.3
		data lane LP-TX from 85 % to
		15 % fall time (T _{FLP}) – 1.1.4
		data lane LP-TX slew rate versus CLOAD
		$(\delta V/\delta t_{SR}) - 1.1.5$
		data lane LP-TX pulse width of
		exclusive-OR clock (T _{LP-PULSE-TX}) - 1.1.6
		data lane LP-TX period of exclusive-OF
		clock (T _{LP-PER-TX}) - 1.1.7
	group 2 (5 tests): clock lane LP-TX	clock lane LP-TX Thevenin output high
	signaling requirements	level voltage (V _{OH}) − 1.2.1
		clock lane LP-TX Thevenin output low
		level voltage (V _{OL}) − 1.2.2
		clock lane LP-TX from 15 % to
		85 % rise time (T _{RLP}) – 1.2.3
		clock lane LP-TX from 85 % to
		15 % fall time (T _{FLP}) – 1.2.4
		clock lane LP-TX slew rate versus C _{LOA}
		$(\delta V/\delta t_{SR}) - 1.2.5$
	group 3 (16 tests): data lane HS-TX	data lane HS entry: data lane T _{LPX} value
	signaling requirements	– 1.3.1
		data lane HS entry: data lane
		T _{HS-PREPARE} value – 1.3.2
		data lane HS entry: data lane
		T _{HS-PREPARE} + T _{HS-ZERO} value – 1.3.3
		data lane HS-TX differential voltages
		$V_{OD(0)}$ and $V_{OD(1)} - 1.3.4$
		data lane HS-TX differential voltage
		mismatch ΔV _{OD} – 1.3.5

	T	
		data lane HS-TX single-ended output
		voltages V _{OHHS(DP)} and V _{OHHS(DN)} – 1.3.6 data lane HS-TX static common-mode
		voltages $V_{CMTX(1)}$ and $V_{CMTX(0)} - 1.3.7$
		data lane HS-TX static common-mode
		voltage mismatch $\Delta V_{CMTX(1.0)} - 1.3.8$
		data lane HS-TX dynamic common-level
		variations from 50 MHz to 450 MHz
		$\Delta V_{CMTX(LF)} - 1.3.9$
		data lane HS-TX dynamic common-level
		variations above 450 MHz ΔV _{CMTX(HF)} –
		1.3.10
		data lane HS-TX from 20 % to 80 % rise
		time t _R - 1.3.11
		data lane HS-TX from 80 % to 20 % fall
		time $t_F - 1.3.12$ data lane HS exit: $T_{HS-TRAIL}$ value $- 1.3.13$
		data lane HS exit: from 30 % to 85 %
		post-EoT rise time $T_{REOT} - 1.3.14$
		data lane HS exit: T _{EOT} value – 1.3.15
		data lane HS exit: T _{HS-EXIT} value – 1.3.16
D-PHY	group 4 (18 tests): clock lane HS-TX	clock lane HS entry: T _{LPX} value – 1.4.1
	signaling requirements	clock lane HS entry: T _{CLK-PREPARE} value –
		1.4.2
		clock lane HS entry:
		T _{CLK-PREPARE} + T _{CLK-ZERO} value – 1.4.3
		clock lane HS-TX differential voltages
		V _{OD(0)} and V _{OD(1)} – 1.4.4 clock lane HS-TX differential voltage
		mismatch $\Delta V_{OD} - 1.4.5$
		clock lane HS-TX single-ended output
		voltages $V_{OHHS(DP)}$ and $V_{OHHS(DN)} - 1.4.6$
		clock lane HS-TX static common-mode
		voltages $V_{CMTX(1)}$ and $V_{CMTX(0)} - 1.4.7$
		clock lane HS-TX static common-mode
		voltage mismatch ΔV _{CMTX(1,0)} – 1.4.8
		clock lane HS-TX dynamic common-level
		variations from 50 MHz to 450 MHz
		ΔV _{CMTX(LF)} – 1.4.9 clock lane HS-TX dynamic common-level
		variations above 450 MHz $\Delta V_{CMTX(HF)}$ –
		1.4.10
		clock lane HS-TX from 20 % to 80 % rise
		time t _R - 1.4.11
		clock lane HS-TX from 80 % to 20 % fall
		time t _F – 1.4.12
		clock lane HS exit: T _{CLK-TRAIL} value –
		1.4.13
		clock lane HS exit: from 30 % to 85 % post-EoT rise time T _{REOT} – 1.4.14
		clock lane HS exit: T _{EOT} value – 1.4.15
		clock lane HS exit: T _{HS-EXIT} value – 1.4.16
		clock lane HS clock instantaneous: UI _{INST}
		value – 1.4.17
		clock lane HS clock delta UI: (ΔUI) value
		– 1.4.18
	group 5 (6 tests): HS-TX clock-to-data	HS entry: T _{CLK-PRE} value – 1.5.1
	lane timing requirements	HS exit: T _{CLK-POST} value – 1.5.2
		HS clock rising edge alignment to first
		payload bit – 1.5.3
		data-to-clock skew (T _{SKEW[TX]}) – 1.5.4 initial HS skew calibration burst
		T _{SKEWCAL-SYNC} T _{SKEWCAL} 1.5.5
		periodic HS skew calibration burst
		T _{SKEWCAL-SYNC} T _{SKEWCAL} — 1.5.6
	I .	SALTTONE OTHO - GIVENONE

R&S®RTO-K27 MIPI D-PHY 2.5 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K27 performs D-PHY compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10. The numbers behind the test refer to the MIPI CTS for D-PHY V2.0, V2.1 and V2.5.

supported D-PHY complianc		
)-PHY	group 1 (7 tests): data lane LP-TX signaling requirements	data lane LP-TX Thevenin output high level voltage (V _{OH}) – 1.1.1
		data lane LP-TX Thevenin output low
		level voltage (V _{OL}) – 1.1.2
		data lane LP-TX from 15 % to
		85 % rise time (T _{RLP}) – 1.1.3
		data lane LP-TX from 85 % to
		15 % fall time (T _{FLP}) – 1.1.4
		data lane LP-TX slew rate versus C _{LOAD}
		$(\delta V/\delta t_{SR}) - 1.1.5$
		data lane LP-TX pulse width of
		exclusive-OR clock (T _{LP-PULSE-TX}) – 1.1.6
		data lane LP-TX period of exclusive-OR
		clock (T _{LP-PER-TX}) – 1.1.7
	group 2 (5 tests): clock lane LP-TX	clock lane LP-TX Thevenin output high
	signaling requirements	level voltage (V _{OH}) – 1.2.1
	olgitaling rodalionionio	clock lane LP-TX Thevenin output low
		level voltage (V _{OL}) – 1.2.2
		clock lane LP-TX from 15 % to
		85 % rise time (T _{RLP}) – 1.2.3
		clock lane LP-TX from 85 % to
		15 % fall time (T _{FLP}) – 1.2.4
		clock lane LP-TX slew rate versus C _{LOAF}
		$(\delta V/\delta t_{SR}) - 1.2.5$
	group 3 (16 tests): data lane HS-TX	data lane HS entry: data lane T _{LPX} value
	signaling requirements	1.3.1
		data lane HS entry: data lane
		T _{HS-PREPARE} value – 1.3.2
		data lane HS entry: data lane
		T _{HS-PREPARE} + T _{HS-ZERO} value – 1.3.3
		data lane HS-TX differential voltages
		$V_{OD(0)}$ and $V_{OD(1)} - 1.3.4$
		data lane HS-TX differential voltage
		mismatch ΔV _{OD} – 1.3.5
		data lane HS-TX single-ended output
		voltages V _{OHHS(DP)} and V _{OHHS(DN)} – 1.3.6
		data lane HS-TX static common mode
		voltages $V_{CMTX(1)}$ and $V_{CMTX(0)} - 1.3.7$
		data lane HS-TX static common mode
		voltage mismatch ΔV _{CMTX(1.0)} – 1.3.8
		data lane HS-TX dynamic common-leve
		variations from 50 MHz to 450 MHz
		$\Delta V_{CMTX(LF)} - 1.3.9$
		data lane HS-TX dynamic common-leve
		variations above 450 MHz ΔV _{CMTX(HF)} –
		1.3.10
		data lane HS-TX from 20 % to 80 % rise time $t_R - 1.3.11$
		data lane HS-TX from 80 % to 20 % fall
		time $t_F - 1.3.12$
		data lane HS exit: T _{HS-TRAIL} value – 1.3.1
		data lane HS exit: from 30 % to 85 %
		post-EoT rise time T _{REOT} – 1.3.14
		•
		data lane HS exit: T _{EOT} value – 1.3.15

D-PHY	group 4 (19 tests): clock lane HS-TX	clock lane HS entry: T _{LPX} value – 1.4.1
51111	signaling requirements	clock lane HS entry: T _{CLK-PREPARE} value –
	eignamig requiremente	1.4.2
		clock lane HS entry:
		T _{CLK-PREPARE} + T _{CLK-ZERO} value – 1.4.3
		clock lane HS-TX differential voltages
		$V_{OD(0)}$ and $V_{OD(1)} - 1.4.4$
		clock lane HS-TX differential voltage
		mismatch $\Delta V_{OD} - 1.4.5$
		clock lane HS-TX single-ended output
		,
		voltages V _{OHHS(DP)} and V _{OHHS(DN)} – 1.4.6
		clock lane HS-TX static common mode
		voltages V _{CMTX(1)} and V _{CMTX(0)} – 1.4.7
		clock lane HS-TX static common mode
		voltage mismatch ΔV _{CMTX(1, 0)} – 1.4.8
		clock lane HS-TX dynamic common-level
		variations from 50 MHz to 450 MHz
		$\Delta V_{CMTX(LF)} - 1.4.9$
		clock lane HS-TX dynamic common-level
		variations above 450 MHz ΔV _{CMTX(HF)} –
		1.4.10
		clock lane HS-TX from 20 % to 80 % rise
		time t _R – 1.4.11
		clock lane HS-TX from 80 % to 20 % fall
		time $t_F - 1.4.12$
		clock lane HS exit: T _{CLK-TRAIL} value -
		1.4.13
		clock lane HS exit: from 30 % to 85 %
		post-EoT rise time T _{REOT} – 1.4.14
		clock lane HS exit: T _{EOT} value – 1.4.15
		clock lane HS exit: T _{HS-EXIT} value – 1.4.16
		clock lane HS clock instantaneous: UI _{INST}
		value - 1.4.17
		clock lane HS clock delta UI:
		(ΔUI) value – 1.4.18
		TX spread spectrum clocking (SSC)
		requirements (1.4.19)
	group 5 (9 tests): HS-TX clock-to-data	HS entry: T _{CLK-PRE} value – 1.5.1
	lane timing requirements	HS exit: T _{CLK-POST} value – 1.5.2
	3 1 1 1 1	HS clock rising edge alignment to first
		payload bit – 1.5.3
		data-to-clock skew (T _{SKEW[TX]}) – 1.5.4
		initial HS skew calibration burst
		T _{SKEWCAL-SYNC} T _{SKEWCAL} – 1.5.5
		periodic HS skew calibration burst
		T _{SKEWCAL-SYNC} T _{SKEWCAL} - 1.5.6
		alternate calibration sequence T _{ALTCAL-SYNC}
		and T _{ALTCAL} – 1.5.8
		preamble sequence T _{PREAMBLE} and
		T _{EXTSYNC} – 1.5.9
		clock and data lane TX HS-Idle T _{HS-IDLE} -
		POST, T _{HS-IDLE-CLKHS0} , T _{HS-IDLE-PRE} – 1.5.10
	eye test (3 tests)	clock lane HS clock delta UI (ΔUI) –1.4.18
		clock lane HS clock period jitter -1.4.20
		HS-TX data and clock eye diagram –1.5.7

R&S®RTO-K31 power analysis

General description	The R&S®RTO-K31 power analysis option extends the R&S®RTO firmware with		
	measurement functionality focused on switched mode power supplies (SMPS) and		
In most	DC/DC converters.	avaluation of navor quality at an	
Input	quality	evaluation of power quality at an AC input; measures real power, apparent power, reactive power, power factor and phase angle of power, frequency, crest factor, RMS of voltage and current	
	harmonics	measures up to the 40th harmonic of the incoming line frequency; precompliance checking for IEC 61000-3-2 (A, B, C, D), RTCA DO-160, MIL-STD-1399, max. limit checks	
	inrush current	measures peak inrush current; multiple measurement zones configurable with analysis of the post-inrush behavior	
Switching/control loop	slew rate	The slope of current or voltage is measured at start and end of the switching cycle.	
	modulation	measures modulation of switching frequency and duty cycle under steady state and start-up conditions	
	dynamic on-resistance	measures resistance of the switching transistor(s) in active state	
Power path	efficiency (only for 4 channel devices)	measures input and output power to calculate the efficiency of an SMPS	
	loss	measures switching loss and conduction loss of a power device	
	safe operating area (SOA)	checks violation of voltage and current limits in which a power device can operate without damage; current versus voltage view (linear or log); violation mask is user-defined and editable in linear and log-log views	
	turn on/off	measures relationship between AC and DC current, when turning the SMPS off and on	
Output	ripple	measures AC components of output voltage and current, AC RMS, frequency, duty cycles, min./max./peak-to-peak amplitude	
	spectrum	FFT analysis of output, measurement of frequency peaks	
	transient response	This measurement captures the device behavior between the event of load changes and stabilization; includes peak (voltage, time), settling time, rise time, overshoot and delay	
Deskew	automated	By using the R&S®RT-ZF20 probe deskew and calibration test fixture and Rohde & Schwarz voltage and current probes, the skew between the voltage and current signal is compensated automatically.	
Reporting	easy reporting: Click to save a measurement. Report generation using user-selected test results from historical and currently active tests. Put repeated and/or different measurements in one report.		

R&S®RTO-K35 bus analysis

General description	The R&S®RTO-K35 bus analysis op functions for dedicated protocols.	tion adds bus measurements and analysis
	supported protocol options	R&S®RTO-K1 (I ² C, SPI), R&S®RTO-K2 (UART), R&S®RTO-K3 (CAN, LIN), R&S®RTO-K8 (Ethernet), R&S®RTO-K9 (CAN-FD), R&S®RTO-K10 (SENT), R&S®RTO-K40 (RFFE), R&S®RTO-K57 (100BASE-T1)
Measurements	field value	allows for the selection of frame types and displays the value of a specified field; the value can be displayed as track and histogram
	frame to frame	measures the distance between the starts of two selectable frame types in seconds
	trigger to frame	measures the distance between the trigger event and the start of a selectable frame type in seconds; alternatively, it measures the distance between the start of a selectable frame type and the trigger event
	frame count	counts the total number of frames in each acquisition
	gap time	measures the distance between the end of a selectable frame type to the start of another selectable frame type in seconds
	bus idle ratio	measures the percentage of idle time on a bus; idle time is defined as the time where the bus is not occupied by frames
	main bit rate	measures the main bit rate of a protocol based on the relevant bits in a frame; if a protocol provides multiple bit rates, the most relevant bit rate is being measured
	secondary bit rate	for protocols with multiple bit rates, the secondary bit rate is available
	frame error count	counts the total number of erroneous frames in each acquisition
	frame error rate	measures the percentage of erroneous frames in relation to the total frames
	consecutive frame error rate	measures the percentage of follow up (consecutive) frame errors, ignoring all single frame errors

R&S®RTO-K39 user-defined math with Python

General description	The R&S®RTO-K39 user-defined math option provides a Python interface to apply user
	functions defined by Python scripts to the waveform processing. The output can be
	visualized as a waveform math signal.

R&S®RTO-K40 MIPI RFFE serial triggering and decoding

Protocol configuration	signal type	two channel, single-ended
	bit rate	auto-detected
	auto threshold setup	assisted threshold configuration
	full autoset	full autoset of horizontal and vertical
		settings and auto threshold setup
	source (SCLK, SDATA)	any two input channels, math waveforms,
		reference waveforms, or logical channels
	supported version	1.X, 2.0,2.1 and 3.0
	read mode	standard or sRead mode
	glitch filter	configurable glitch filter
	gap detection	detect gaps between sequences

Trigger	trigger event setup	sequence start, sequence stop, register 0 write, register write, register read, extended register write, extended register read, extended register write long, extended register read long, error condition types
	sequence start setup	4 bit slave address; conditions =, ≠, <, ≤, >, ≥, in range, out of range
	sequence stop setup	4 bit slave address; conditions =, ≠, <, ≤, >, ≥, in range, out of range
	register 0 write setup	4 bit slave address, 7 bit data word; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options
	register write/read	4 bit slave address, 5 bit register address, 8 bit data word; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options
	extended register write/read	4 bit slave address; 8 bit address, byte count: 0 to 15 (inclusive), data pattern: 1 to 16 byte (hex or binary); conditions =, \neq , <, \leq , >, \geq , in range, out of range for each of these options; index: 1 to 16 selects the specific data frame byte; conditions =, \neq , <, \leq , >, \geq , in range
	extended register write long/read long	4 bit slave address, 8 bit address, byte count: 0 to 7 (inclusive), data pattern: 0 to 8 byte (hex or binary); conditions =, \neq , <, \leq , >, \geq , in range, out of range for each of these options; index: 1 to 8 selects the specific data frame byte; conditions =, \neq , <, \leq , >, \geq , in range
	interrupt summary and notification masked write	 4 bit slave address, bit count 0 to 32, notification and interrupt bits 4 bit slave address; 8 bit address, 8 bit mask, 8 bit data pattern; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; frame byte; conditions =, ≠, <, ≤, >, ≥, in range
	master ownership handover	2 bit MID; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; frame byte; conditions =, ≠, <, ≤, >, ≥, in range
	master write/read	2 bit MID, 8 bit address, 16 bit data pattern; conditions =, ≠, <, ≤, >, ≥, in range, out of range for each of these options; frame byte; conditions =, ≠, <, ≤, >, ≥, in range
	master context transfer write/read	2 bit MID, 8 bit byte count, 8 bit address, data pattern: 1 to 8 byte (hex or binary); conditions =, \neq , <, \leq , >, \geq , in range, out of range for each of these options; index: 1 to 256 selects the specific data frame byte; conditions =, \neq , <, \leq , >, \geq , in range
	error condition	SSC error; length error, bus park error, parity error, no response, unknown sequence, version error, min. gap between frames: 1 ns to 10 us

Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, decode layers
	color coding	sequence, frame, error
	data format	hex, octal, binary, ASCII, signed, unsigned
	decode layer	off, edges, bit
Search	search event setup	sequence start, sequence stop, register 0 write, register write, register read, extended register write, extended register read, extended register write long, extended register read long, master read, master write, master ownership handover, interrupt summary and notification, error condition types
	event settings	same as trigger event settings

R&S®RTO-K42 MIPI D-PHY serial triggering and decoding

Protocol configuration	signal type	clock, data (differential or single-ended)
	bit rate	selectable without clock lane (1 Mbps to
		2.5 Gbps),
		auto detect with clock lane
	source	any input channels, math waveforms,
		reference waveforms
	variants	D-PHY v. 1.2, CSI-2 v.1.2, DSI v. 1.3
Trigger	trigger event setup	HS start of packet,
	,	HS end of packet,
		HS packet header,
		HS data,
		LP escape mode,
		LP lane turnaround,
		LP HS request
	HS packet header setup	virtual channel, data type, word count; conditions =, \neq , <, \leq , >, \geq , in range, out of range for data and word count
	HS data	virtual channel, data type, word count,
	1.0 23.0	data value, data index; conditions =, ≠, <,
		≤, >, ≥, in range, out of range for data
		count, word count, data value
	LP escape mode	escape mode, data value, data index;
		conditions =, \neq , <, \leq , >, \geq , in range, out of
		range for escape mode and data value
Decode	display type	decoded bus, tabulated list, details,
	3 37 37 3	decode layers
	color coding	high speed: frames according to trace,
	3	cells:
		low power: escape word, data word
	data format	hex, octal, binary, signed, unsigned
	decode layer	off, HS edges, HS binary, HS burst bits,
	,	HS burst bytes, HS merged bytes, HS
		merged words, LP edges, LP states, LP
		active states, LP binary
	result export	export of all result data into CSV, XML,
	· ·	HTM and PY file formats
Search	search event setup	HS start of packet,
	·	HS end of packet,
		HS packet header,
		HS data,
		LP escape mode,
		LP lane turnaround,
		LP HS request
	event settings	same as trigger event setup

R&S®RTO-K44 MIPI M-PHY serial triggering and decoding

		•
Protocol configuration	signal type	up to 4 channels,
		differential
	bit rate	clock recovery
	source (SDATA)	analog and math channels,
		reference waveforms
	variants	UniPro 1.6 and M-PHY 4.0
Trigger	trigger event setup	M-PHY burst,
		M-PHY adapt,
		M-PHY LCC,
		UniPro DL_PDU frames,
		UniPro PACP frames,
		UniPro trigger upper frames,
		M-PHY/UniPro errors
Decode	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, details, decode
		layers
	color coding	for different cells/frame types
	data format	K/D symbols; with UniPro additionally:
		hex, octal, binary, signed, unsigned
	decode layer	off, edges, bit, 8b/10b symbols, LCC bits;
		with UniPro additionally: filter/descrambler,
		lane merge, byte
Search	search event setup	M-PHY burst,
		M-PHY adapt,
		M-PHY LCC,
		UniPro DL_PDU frames,
		UniPro PACP frames,
		UniPro trigger upper frames,
		M-PHY/UniPro errors

R&S®RTO-K50 Manchester and NRZ serial triggering and decoding

Dueta and configuration	alamat tura	a a la atala la
Protocol configuration	signal type	selectable,
		one channel, differential or single-ended,
	h:4 va4a	two channel, differential or single-ended
	bit rate	auto detected, adjustable
	auto threshold setup	assisted threshold configuration
	source	analog, math. channels, logical (only NRZ)
	bit encoding variants	Manchester,
		Manchester II,
		NRZ clocked,
		NRZ unclocked
	properties	active state (high/low), idle state
		(high/low), clock edge (first/second)
	frame separation	gap, enable signal (only NRZ)
Frame format	frame	multiple frame management,
		frame identification and sync,
		variable length frames,
		variable number of cells
	cells	name, size (bits), numeric format,
		bit order, color
	file storage of frame format	save/load as xml files
Trigger	variants	all supported bit encodings
	trigger event setup	frame start, pattern, advanced trigger
	frame start	gap, start bit
	pattern	up to 256 bit pattern within 65 535 bit
		frame 13
	advanced trigger	frame type (with OR combinations), frame
		fields (with AND combinations), frame field
		data; conditions =, \neq , <, \leq , >, \geq , in range,
		out of range for data count, word count,
		data value; error types
Decode	display type	decoded bus, logical signal, bus signal,
		tabulated list, result details, decode layers
	color coding	according to cell configuration table
	data format	according to cell configuration table
	decode layer	edges, binary
Search	event settings	same as advanced trigger settings
Filter		ode events that shall be shown in the result table.
	Events that do not match the criteria set will not be displayed in the table when the filter	
	is turned on.	
	settings	same as advanced trigger settings
	, 3 -	

¹³ The pattern trigger will not be effective after Manchester violations.

R&S®RTO-K52 8b10b serial triggering and decoding

8b10b decoding		
Protocol configuration	signal type	one/two channel, differential, single-ended
-	bit rate	selectable/adjustable auto configuration, ideal for bitrate up to 6.25 Gbit/s
	auto threshold setup	assisted threshold configuration
	one click setup	convenient way for perfect decode results; auto scaling of waveforms, auto threshold and bitrate estimation on one click
	source (differential, single-ended D+/D-)	full combination of either analog, math, reference channels
	variants	all layer 1 (physical layer) encoded 8b/10b protocols, recommended for Ethernet, FibreChannel 1G, 2G, PCI Express, Serial ATA, Serial Rapid IO (SRIO), XAUI
Trigger	trigger event setup	symbols, errors
33	symbols	K/D symbol (8 bit/10 bit), complex expression (combination of K/D symbols, wildcards, disparity)
	errors	disparity, glitching and unknown symbol
Decode	display type	decoded bus, bus signal, tabulated list, details, decode layers
	color coding	sync symbol, K symbols, data (Dx.y) coding and error coding
	data format	hex, 10bit and K/D representation
	decode layer	edges, bit
Search	search event setup	symbols, errors
	event settings	same as trigger event settings

R&S®RTO-K55 MDIO serial triggering and decoding

Protocol configuration	bit rate	up to 5 Mbps (auto-detected)
	auto threshold setup	assisted threshold configuration for
		MDIO triggering and decoding
	device list	associate frame address with symbolic ID
Trigger	source (clock and data)	any input channel or logical channel
	trigger event setup	start, stop, ST, OP, PHY address, register
		address, data
	ST setup	01 (clause 22), 00 clause 45, any
	OP setup	address, write, post read, read, any
	PHY address setup	5 bit address (hex, decimal, octal or
		binary); equal
	PHY register (clause 22)/device type	5 bit value (hex, decimal, octal or binary);
	(clause 45) setup	equal
	data (clause 22)/data/address (clause 45)	16 bit value (hex, decimal, octal or
		binary); equal
Decode	source (clock and data)	any input channel, math waveform,
		reference waveform, logical channel
	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, decode layers
	color coding	frame, PHY address, PHY register,
		address, data, turnaround
	PHYAD/PRTAD	symbolic names for user-defined
		addresses
	address/data field format	hex, decimal, octal, binary, ASCII
	decode layer	edges, binary
Search	source (clock and data)	any input channel, math waveform,
		reference waveform, logical channel
	search event setup	start, stop, ST, OP, PHY address, register
		address, data
	event settings	same as trigger event settings

R&S®RTO-K57 Ethernet (100BASE-T1) serial triggering and decoding

Protocol configuration	signal type	one channel differential, two channels single-ended, optional additional use of reverse channels for signal improvement: one channel differential, two channels single-ended
	symbol rate	66.667 Msymbol/s, adjustable for testing
	thresholds	upper/lower, assisted threshold configuration
	source	any analog input channels, math waveforms, reference waveforms
	polarity	normal, inverted
	mode	slave, master
Trigger	trigger event setup	frame start, MAC frame, idle frame, error conditions
	MAC frame setup	destination address (condition =, \neq , <, >, \geq , \leq , in range, out of range), source address (condition =, \neq , <, >, \geq , \leq , in range, out of range), length/type (condition =, \neq , <, >, \geq , \leq , in range, out of range), frame check (condition =, \neq , <, >, \geq , \leq , in range, out of range), data (condition =, \neq , <, >, \geq , \leq , in range, out of range), data index (condition =, <, >, \geq , \leq , range)
	error condition setup	preamble error, CRC error, SFD error
Decode	display type	decoded bus, tabulated list, details, decode layers
	color coding	for different cells types
	data format	hex, octal, binary, signed, unsigned
	decode layer	reversed bits, descrambled bits, scrambled bits, ternary symbols
	result export	export of all result data into CSV, XML, HTM and PY file formats
Search	search event setup	frame start, MAC frame, idle frame, error conditions
	event settings	same as trigger event settings

R&S®RTO-K58 Ethernet (1000BASE-T1) serial triggering and decoding

	-	
Protocol configuration	signal type	one channel differential, two channels single-ended, optional additional use of reverse channels for signal improvement: one channel differential, two channels single-ended
	symbol rate	750 Msymbol/s, adjustable for testing
	thresholds	automatically adjusted during decoding
	source	any analog input channels, math
		waveforms, reference waveforms
	polarity	normal, inverted
	mode	slave, master
Trigger	trigger event setup	frame start,
		MAC frame,
		idle frame,
		error conditions
	MAC frame setup	destination address (condition =, \neq , <, >, \geq , \leq , in range, out of range), source address (condition =, \neq , <, >, \geq , \leq , in
		range, out of range), length/type (condition =, \neq , <, >, \geq , in range, out of
		range), frame check (condition =, \neq , <, >, \geq , \leq , in range, out of range), data (condition =, \neq , <, >, \geq , \leq , in range, out of range), data index (condition =, <, >, \geq , \leq ,
	error condition setup	range) RS-FEC error, out of range error, CRC error, SFD error
Decode	display type	decoded bus, tabulated list, details, decode layers
	color coding	for different cells types
	data format	hex, octal, binary, signed, unsigned
	decode layer	ternary symbols, scrambled bits, descrambled bits, corrected RS-FEC symbols
	result export	export of all result data into CSV, XML, HTM and PY file formats
Search	search event setup	frame start, MAC frame, idle frame,
		error conditions
	event settings	same as trigger event settings

R&S®RTO-K60 USB 1.0/1.1/2.0 serial triggering and decoding

		•
Protocol configuration	signal type	single-ended, differential
	protocol type	low, full, high speed and HSIC
	bit rate	standard bit rates (1.5/12/480 Mbit/s)
	source	any input channel
	probe type	
	for low and full speed	single-ended probe
	for high speed	differential probe (R&S®RT-ZDx)
	for HSIC	single-ended probe(R&S®RT-ZSx)
	auto threshold setup	assisted threshold configuration for USB
		triggering and decoding
Trigger	trigger event setup	start of packet, end of packet, PID token (IN, OUT, SETUP, SOF), PID data (Data0, Data1, Data2 ¹⁴ , MData ¹⁴), PID handshake (ACK, NAK, STALL, NYET ¹⁴), PID special (PRE ¹⁵ , ERR ¹⁴ , SPLIT ¹⁴ , PING ¹⁴); bus state (reset ¹⁵ , resume ¹⁵ , suspend ¹⁵); error condition
	address, endpoint and frame setup SC, port, SEU, ET check (SPLIT) 15	condition =, ≠, ≥, ≤, in range, out of range
	data setup	data pattern up to 4 byte (hex, decimal, octal, binary or ASCII), bit separately configurable (1, 0 or don't care); condition =, ≠; position based or window based triggering (first occurrence in packet payload)
	error condition	any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹⁵ and glitching error
Decode	source	any input channel, math waveform
	display type	decoded bus, logical signal, bus + logical signal, tabulated list
	color coding	packet identifier, payload length, frame, address, endpoint, data payload, CRC5, CRC16, error condition
	data format	hexadecimal, decimal, octal, binary, ASCII, unsigned
Search	search event setup	combination of start of packet, PID token (IN, OUT, SETUP, SOF), PID data (Data0, Data1, Data2 ¹⁴ , MData ¹⁴), PID handshake (ACK, NAK, STALL, NYET ¹⁴), PID special (PRE ¹⁵ , ERR ¹⁴ , SPLIT ¹⁴ , PING ¹⁴); error condition (any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹⁵ and glitching error)
	address, endpoint and frame setup SC, port, SEU, ET check (SPLIT)	condition =, \neq , \geq , \leq , in range, out of range
	data setup	data pattern up to 4 byte (hex, decimal, octal, binary or ASCII), bit separately configurable (1, 0 or don't care); condition =, ≠; position based or window based triggering (first occurrence in packet payload)
	error condition	any error, PID error, CRC5 error, CRC16 error, bit stuffing error, unexpected PID, SE1 error ¹⁵ and glitching error

¹⁴ Only available in high speed and HSIC.

 $^{^{\}rm 15}\,$ Only available in low and full speed.

R&S®RTO-K61 USB 3.1 Gen 1 serial triggering and decoding

The R&S®RTO-K61 is suitable for R&S®RTO2064 models only.

Protocol configuration	signal type	one channel
C C	bit rate	auto detected
	auto threshold setup	supported
	source	any analog input channels, math
		channels, reference channels
	scrambling	selectable
	digital signal processing	CTLE continuous time equalizer;
	angitan engitan processing	DFE decision feedback equalizer
Trigger	trigger event setup	frame start,
93	99-1 - 1-1-1-p	frame content,
		errors
	frame content	USB packet types: TSEQ, TSET1,
	Tamo content	TSET2, set link function, U2 inactivity
		timeout, vendor device test, port
		capability, port configuration, port, config.
		resp., link delay meas, ACK, NRDY,
		ERDY, STATUS, STALL, function wake,
		latency tolerance, bus interval, adjust,
		host role request, sublink speed, ping,
		ping response, data packet header, data
		packet payload, DPP aborted,
		isochronous timestamp, link command,
		info, BRST, BDAT, BERC, BCNT, idle;
		fields according to selected USB packet
		with content conditions =, \neq , <, >, \geq , in
		range, out of range
	errors	CRC, length, value out of range
Decode	display type	decoded bus, tabulated list, details,
	3 -1 -9 -91 -	decode layers
	color coding	cell and frame types
	data format	hexadecimal, octal, binary, ASCII, signed,
		unsigned, 8b/10b symbols
	decode layer	edges, bit, scrambled symbols,
	, , , , , , , , , , , , , , , , , , , ,	descrambled symbols, byte
	result export	export of all result data into CSV, XML,
	, and the second	HTM and PY file formats
Search	search event setup	frame start,
	, , , , , , , , , , , , , , , , , , ,	frame content,
		errors
	event settings	same as trigger event settings
	2.on counge	calle de lingger event collinge

R&S®RTO-K63 USB power delivery serial triggering and decoding

Protocol configuration	signal type	one channel
	bit rate	auto detected
	source	any analog input channel, logical channels, math channels, reference channels
	thresholds	data, advertisements
	data details	detailed breakdown selectable
Trigger	trigger event setup	frame start
		frame content
		errors
	frame content	extended, NumDataObjs, MsgID, PwrRole/Plug, Rev, DataRole, MsgType, voltage advertisements (content conditions =, ≠, <, >, ≥, ≤, in range, out of range)
	errors	4b/5b, preamble, CRC, length, SOP warning
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, details, decode layers
	color coding	cell and frame types
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, bits, 4b5b symbols
Search	search event setup	frame start
		frame content
		errors
	event settings	same as trigger event settings

R&S®RTO-K64 USB 3.1 SSIC serial triggering and decoding

Protocol configuration	signal type	up to 4 lanes differential
	bit rate	auto detected
	source	any analog input channels, math channels,
		reference channels
	scrambling	selectable
	digital signal processing	CTLE continuous time equalizer;
		DFE decision feedback equalizer
Trigger	trigger event setup	frame start,
		frame content,
		errors
	frame content	USB packet types: TSEQ, TSET1, TSET2,
		set link function, U2 inactivity timeout,
		vendor device test, port capability, port
		configuration, port, config. resp., link delay
		meas, ACK, NRDY, ERDY, STATUS,
		STALL, function wake, latency tolerance,
		bus interval, adjust, host role request,
		sublink speed, ping, ping response, data
		packet header, data packet payload, DPP
		aborted, isochronous timestamp, link
		command, info, BRST, BDAT, BERC,
		BCNT, idle;
		fields according to selected USB packet
		with content conditions =, \neq , <, >, \geq , in
		range, out of range
	errors	CRC, length, value out of range
Decode	display type	decoded bus, tabulated list, details,
		decode layers
	color coding	cell and frame types
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, bit, byte, 8b/10b symbols, LCC
		bits, descrambler, lane merge
Search	search event setup	frame start,
		frame content,
		errors
	event settings	same as trigger event settings

R&S®RTO-K65 SpaceWire serial triggering and decoding

Protocol configuration	signal type	two channels: strobe and data
		(differential or single-ended)
	bit rate	auto adjust (strobe + data)
	source	any analog input channels, logical
		channels ¹⁶ , math channels, reference
		channels
Trigger	trigger event setup	control frame, data pattern, null frame,
		time code, error condition
	control frame setup	any, FCT, EOP, EEP
	data pattern setup	8 bit (condition =, \neq , <, >, \geq , \leq , in range,
		out of range)
	time code setup	8 bit (condition =, \neq , <, >, \geq , \leq , in range,
		out of range)
	errors condition setup	parity, ESC
Decode	display type	decoded bus, logical signal, bus + logical
		signal, tabulated list, decode layers
	color coding	control frame, data frame, null frame, time
		code
	data format	hex, octal, binary, signed, unsigned
Search	search event setup	control frame, data pattern, null frame,
	·	time code, error
	event settings	same as trigger event settings

¹⁶ SpaceWire protocol trigger on logical channels is not available.

R&S®RTO-K72 PCI Express 1.1/2.0 serial triggering and decoding

The R&S®RTO-K72 is suitable for R&S®RTO2064 models only.

Protocol configuration	signal type	up to four channels (x1, x2, x4 link size)
		differential signals
	bit rate	predefined 2.5 Gbit/s for Gen 1 and
		5 Gbit/s for Gen 2
	source	any analog input channels, math
		channels, reference channels
	digital signal processing	CTLE continuous time equalizer;
		DFE decision feedback equalizer
Trigger	trigger event setup	TLP (transaction layer packets), DLLP
		(data layer packets), ordered sets, errors
	transaction layer packets (TLP)	any type,
		memory request (32/64 bit, R/W, ordering,
		snoop, seg. number, requester ID), I/O
		transactions, configuration requests,
		message requests (incl. routing and
		message code), completion packets
		(status, completer ID), atomic operation
		(FetchAdd, SWAP, CAS) for 32/64 bit
	data layer packets (DLLP)	any type, Ack and Nak (seq. number),
	data tayor paonoto (BEET)	InitFC1, InitFC2, updateFC (credit type C,
		NP, Cpl and virtual channel), power
		management with PM type, vendor packet
		format.
		multi-root I/O virtualization (MRDLLP):
		MRInit (phase, VH FC, mixed type,
		authorized, device/port type), MRReset
		(A, VH Group), MRUpdateFC, MRInitFC1
		and MRInitFC2 (VL number, VH absent,
		TLP type, credit type)
	ardarad aata	
	ordered sets	SKP OS, training sequence (TS1, TS2),
		fast training sequence (FTS), electrical
		idle OS, electrical idle exit OS,
		compliance and modified compliance
	Pot.	pattern
	errors condition setup	CRC16, ECRC, LCRC, disparity, invalid
		packets (corrupt header or length errors)
Decode	display type	decoded bus, tabulated list, decode
		layers, detailed result display for packets
	color coding	TLP, DLLP, K-code, D-code, ordered
		sets, errors
	data format	K/D symbol, 8 bit format (hex)
	decode layer	8b10b, descrambled 8b10b, bit
	result export	export of all result data into CSV, XML,
		HTM and PY file formats
Search	search event setup	TLP, DLLP, ordered sets, errors
	event settings	same as trigger event settings

R&S®RTO-K76 CXPI serial triggering and decoding

Protocol configuration	signal type	one channel
_	bit rate	auto-detected/adjustable
	auto threshold setup	assisted threshold configuration
	source (SDATA)	any input channels, math waveforms, reference waveforms or logical channels
Trigger	trigger event setup	frame start, frame types with frame content, error condition
	frame types	normal, normal poll, sleep, long, long poll, PID, PTYPE, PTYPE+PID
	frame content (depending on frame type)	frame ID, NW, CT, DLC, data pattern
	data pattern setup	up to 8 byte (condition =, \neq , <, >, \geq , \leq , in range, out of range), payload data index
	error condition setup	(=, <, >, ≥, ≤, range) IFS, IBS, CRC, length, parity, UART, DLC
Decode	display type	decoded bus, logical signal, bus + logical signal, tabulated list, details, decode layers
	color coding	for different cell types
	data format	hex, octal, binary, signed, unsigned
Search	search event setup	frame start, frame types with data, error types
	event settings	same as trigger event settings

R&S®RTO-K81 PCI Express 1.1/2.0 compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K81 performs PCIe 1.x/2.0 (up to 2.5GT/s) compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10. The option can only be used with an R&S®RTO2064. The chapters after the category refer to PCI Express Base Specification Revision 1.1 and 2.1.

Supported PCle compliand	ce tests	
PCIe 1.1	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min eye width
		median to max jitter
		differential output voltage
	reference clock (1.32)	differential input high voltage
		differential input low voltage
		duty cycle
		average clock period
		rising edge rate
		falling edge rate
PCIe 2.0	signal quality (4.3.3)	mean unit interval
		data rate
		template tests
		min eye width
		median to max jitter
		differential output voltage

R&S®RTO-K87 Ethernet compliance test (1000BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K87 performs 1000BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF6 frequency converter and R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The option can only be used with an R&S®RTO with a bandwidth ≥ 2 GHz. The chapters in front of the test cases refer to IEEE 802.3-2018 OPEN Alliance ECU specification supported, where applicable.

Supported 1000BASE-T1 compliance tests		
1000BASE-T1	97.5.3.3 transmitter timing jitter master mode	
	97.5.3.3 transmitter timing jitter slave mode	
	97.5.3.3 transmitter timing MDI jitter	
	97.5.3.6 transmitter clock frequency	
	97.5.3.2 transmitter distortion	
	97.5.3.4 transmitter power spectral density (PSD)	
	97.5.3.4 transmitter power level	
	97.5.3.5 transmitter peak differential output	
	97.5.3.1 maximum output droop	
	97.7.2.1 MDI return loss	
	97.7.2.2 MDI mode conversion loss	
	MDI adapter verification	

R&S®RTO-K88 Ethernet compliance test (MGBASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K88 performs MGBASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE P802.3ch.

Supported MGBASE-T1 compliance tests		
MGBASE-T1 (2.5/5/10G)	149.5.2.1 maximum output droop	
	149.5.2.2 transmitter linearity	
	149.5.2.3 transmitter timing jitter master	
	149.5.2.3 transmitter timing jitter slave	
	149.5.2.3.1 transmit MDI random jitter in master mode	
	149.5.2.3.2 transmit MDI deterministic jitter in master mode	
	149.5.2.4 transmitter power spectral density (PSD) and power	
	level	
	149.5.2.5 transmitter peak differential output	
	149.5.2.6 transmitter clock frequency	
	149.8.2.1 MDI return loss	

R&S®RTO-K89 Ethernet compliance test (10BASE-T1)

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K89 performs 10BASE-T1 compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports the R&S®RT-ZF7A and R&S®RT-ZF8 test fixtures; R&S®ScopeSuite supports Windows 7, 8 and 10. The chapters in front of the test cases refer to IEEE P802.3cg.

Supported 10BASE-T1 compliance tests		
10BASE-T1S	147.5.4.1 transmitter output voltage	
	147.5.4.3 transmitter timing jitter	
	147.5.4.2 transmitter output droop	
	147.5.4.4 transmitter power spectral density (PSD)	
	147.7.2 MDI return loss	
	147.7.3 MDI mode conversion	
10BASE-T1L	146.5.4.1 transmitter output voltage	
	146.5.4.3 transmitter timing jitter	
	146.5.4.5 transmitter clock frequency	
	146.5.4.4 transmitter power spectral density (PSD) and power	
	level	
	146.8.3 MDI return loss	
	146.8.4 MDI mode conversion	

R&S®RTO-K91 DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K91 performs DDR3 (JESD79-3F), DDR3L(JESD79-3-1A.01) and LPDDR3 (JEDS209-3C) compliance test measurements with R&S®ScopeSuite. Furthermore, it enables the DDR3 decode capability to separate read and write bursts as well as the eye analysis function for mask testing on the oscilloscope. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported DDR3 compliance		tCK(ava) (12.1.1)
iming tests	clock timing (12.1)	tCK(avg) (12.1.1)
		tCK(abs) (12.1.2)
		tCL(avg) (12.1.3)
		tCH(avg) (12.1.3)
		tJIT(per) (12.1.4)
		tJIT(duty) (12.1.4)
		tJIT(cc) (12.1.5)
		tERR(nper) (12.1.6)
	data timing (4.13.2, 13.4, 13.6)	tDS(base) (13.6)
		tDH(base) (13.6)
		tDS(derate) (13.6)
		tDH(derate) (13.6)
		tHZ (4.13.2)
		tLZ (4.13.2)
		tDIPW (13.4 note 28)
		tDQSQ (4.13.2)
	otrobo timing (4.12, 4.14, 9.2.1)	tQH (4.13.2)
	strobe timing (4.13, 4.14, 8.3.1)	tDQSCK (4.13.2)
		tLZ (4.13.2)
		tHZ (4.13.2)
		tRPRE (4.13.2)
		tRPST (4.13.2)
		tQSH (4.13.2)
		tQSL (4.13.2)
		tDQSS (4.14.2)
		tDQSH (4.14.2)
		tDQSL (4.14.2)
		tDSS (4.14.2)
		tDSH (4.14.2)
		tWPST (4.14.2)
		tWPRE (4.14.2)
		tDVAC (strobe) (8.3.1)
		tDVAC (clock) (8.3.1)
	command timing (13.5)	tlS (13.5)
	command uning (13.3)	
		tIS (derated) (13.5)
		tlH (13.5)
		tlH (derated) (13.5)
		tIPW (13.5)
		tVAC (CA) (13.5)
	address timing (13.5) DDR3 and DDR3L	tlS (13.5)
		tIS (derated) (13.5)
		tIH (13.5)
		tIH (derated) (13.5)
		tIPW (13.5)
		tVAC (CA) (13.5)
	address timing (4.2) LPDDR3	tISCA (4.2)
		tlHCA (4.2)
		tlPWCA (4.2)
		tVAC (CA) (13.5)
	chip select timing (13.5) DDR3 and	tlS (13.5)
	DDR3L	tlS (derated) (13.5)
	DUNGE	
		tlH (13.5)
		tlH (derated) (13.5)
		tIPW (13.5)
	chip select timing (4.2) LPDDR3	tISCS (4.2)
		tIHCS (4.2)
		tIPWCS (4.2)
		tVAC(CS) (11.5)

Electrical tests single-ended	input slew rate for ADD and CMD DDR3	SR(tIS) rising
measurements	and DDR3L (8.5, 13.5) LPDDR3 (7.6,	SR(tIS) falling
modediomonic	11.5)	SR(tIH) rising
	11.5)	SR(tIH) falling
	input slew rate for DQ and DM DDR3 and	SR(tIS) rising
	DDR3L (8.5, 13.6) LPDDR3 (7.6, 11.6)	SR(tIS) falling
	DDR3E (6.5, 15.6) El DDR3 (7.6, 11.6)	SR(tIH) rising
		SR(tIH) falling
	AC and DC input levels for ADD and CMD	VIH (AC)
	DDR3(8.1.1) DDR3L(3.1) LPDDR3(7.1.1)	VII (AC)
	DDR3(0.1.1) DDR3E(3.1) El DDR3(7.1.1)	VIH (DC)
		VIL (DC)
	AC and DC input levels for DQ and DM	VIH (AC)
	(8.1.2)	VIL (AC)
	(0.1.2)	VIH (DC)
		VII (DC)
	AC input levels for CK and DOS (9.3.3)	VSEH (AC)
	AC input levels for CK and DQS (8.3.3)	` '
	output slow rate for DO (0.2)	VSEL (AC)
	output slew rate for DQ (9.3)	SRQse rising
	AC and DC system to locate for DC (0.0)	SRQse falling
	AC and DC output levels for DQ (9.2)	VOH(AC)
		VOL(AC)
		VOH(DC)
	AC acceptant and and to demand and for ADD	VOL(DC)
	AC overshoot and undershoot for ADD	overshoot amplitude
	and CMD (9.6.1)	overshoot area
		undershoot amplitude
	10 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	undershoot area
	AC overshoot and undershoot for CK, DQ, DQS and DM (9.6.2)	overshoot amplitude
		overshoot area
		undershoot amplitude
	10: (1 1 (0)(1000 (0.0)	undershoot area
Electrical tests differential measurements	AC input levels for CK and DQS (8.3)	VIHdiff (AC)
	A Q . I'ff I'a	VILdiff (AC)
	AC differential cross point voltage for CK	VIX (AC)
	and DQS (8.4)	CDOdiff visions
	differential output slew rate for DQS (9.4)	SRQdiff rising
	differential AO and and language for DOO (0.0)	SRQdiff falling
	differential AC output levels for DQS (9.2)	VOHdiff(AC)
Debug	tuiggor vurito ovala	VOLdiff(AC)
Debug	trigger write cycle	configures the oscilloscope to trigger on a
	triager road avale	write cycle
	trigger read cycle	configures the oscilloscope to trigger on a
DDP2 deceding		read cycle
DDR3 decoding	aignal type	DO DOS
Protocol configuration	signal type bit rate	DQ, DQS
		adjustable
	threshold setup	manual threshold/hysteresis configuration
Danada	Source	analog channels
Decode	display type	decoded bus, tabulated list, details
	color coding	read frame, write frame
	data format	hex, octal, binary, signed, unsigned
	decode layer	edges, bit, words
Search	search event setup	frame content, error
	frame content	data; conditions =, ≠, <, ≤, >, ≥, in range,
		out of range
	error	length, frame incomplete

DDR3 eye diagram General description	The DDR3 eve diagram allows the use	r to generate eve diagrams from long multi-	
Ochoral description	The DDR3 eye diagram allows the user to generate eye diagrams from long multi- period acquisitions of clock signals and serial data signals. It allows the fine control of the signal content that contributes to the eye diagram and enables the development advanced analysis, measurement, mask test and navigation functions.		
General configuration	number of eye diagram instances	up to 4; independently configurable	
3	main source	analog channels, differential channels, math channels, reference channels, track channels	
	timing reference source	analog channels, differential channels, math channels, reference channels, track channels	
	horizontal settings	range, position; expressed in absolute time or relative to user-defined bit rate	
Display	persistence	50 ms to 50 s, or infinite	
	trace colors	predefined or user-defined color tables	
	eye stripe	displays position of eye diagram slices and masks violations time-correlated to the main source waveform; always enabled, for mask tests only, disabled.	
Qualification	gate	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	
	position	start, stop; absolute time or relative to display in percent	
	coupling	none, cursor #, zoom #	
	signal		
	source	analog channels, math channels, reference channels	
	condition	greater than, less than, in range, out of range; relative to selected reference level	
Filter	DDR3 protocol		
	frame type	any, read frame, write frame	
	error	length	
	bit sequence		
	mode	all, level transition, constant level, bit pattern	
	bit pattern setup	up to 8 prefix bits and up to 5 suffix bits with respect to central eye diagram bit	
Mask testing	mask test results		
	counters	acquisitions, slices, sample hits, slice hits fail rate	
	violation details	number and position of mask violation, expressed as time instant and slice index	
	navigation and zoom	use zoom coupling to navigate to violation upon clicking the corresponding table iter	

R&S®RTO-K92 eMMC compliance test

The R&S®RTO-K92 option is available for R&S®RTO2004, R&S®RTO2014, R&S®RTO2024, R&S®RTO2034, R&S®RTO2034 and R&S®RTO2064 models only. The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. R&S®RTO-K92 performs eMMC (HS200, HS400) compliance test measurements with R&S®ScopeSuite. R&S®ScopeSuite supports Windows 7, 8 and 10.

Supported eMMC compliance t		
HS200 (JESD84-B50)	CLK (10.5.2, 10.8.1)	bus signal levels tests (VIH, VIL)
		interface timing tests
		(t _{Period} , rise time, fall time, duty cycle)
	CMD push pull (10.5.2, 10.8.1)	bus signal levels tests
		(VIH, VIL, VOH, VOL)
		interface timing tests
		(setup time, hold time)
	CMD open drain (10.5.1)	bus signal levels tests (VOH, VOL)
	DAT data write (10.5.2, 10.8.1)	bus signal levels tests (VIH, VIL)
		interface timing tests
		(setup time, hold time)
	DAT data read (10.5.2, 10.8.1)	bus signal levels tests (VOH, VOL)
HS400 (JESD84-B50)	CLK (10.5.2, 10.10.1)	bus signal levels tests (VIH, VIL)
		interface timing tests
		(t _{Period} , slew rate, duty cycle distortion,
		minimum pulse width)
	CMD push pull (10.5.2, 10.10.1)	bus signal levels tests
		(VIH, VIL, VOH, VOL)
		interface timing tests
		(setup time, hold time)
	CMD open drain (10.5.1)	bus signal levels tests (VOH, VOL)
	DAT data write (10.5.2, 10.10.1)	bus signal levels tests (VIH, VIL)
		interface timing tests
		(setup time, hold time, slew rate)
	DAT data read (10.5.2, 10.10.2)	bus signal levels tests (VOH, VOL)
		interface timing tests (output skew, output
		hold skew, slew rate)
	data strobe for data read (10.5.2,	bus signal levels tests (VOH, VOL)
	10.10.1)	interface timing tests
		(t _{Period} , slew rate, duty cycle distortion,
		minimum pulse width)

R&S®RTO-K99 R&S®ScopeSuite automation

The option is used in combination with the free-of-charge R&S®ScopeSuite PC software, which can be downloaded from the Rohde & Schwarz website. It requires matching compliance test options (see below). R&S®RTO-K99 makes it possible to automate the supported compliance options remotely. After remote execution of a test case the user can collect the results to process them in a proprietary software to create own reports.

Remote API to execute test cases of R&S®ScopeSuite		
API language		C#
Supported options	R&S®RTO-K22	100BASE-TX, 1000BASE-T
	R&S®RTO-K24	100BASE-T1
	R&S®RTO-K87	1000BASE-T1
	R&S®RTO-K91	DDR3, DDR3L, LPDDR3

R&S®RTO-K121 deembedding base option

General description	The R&S®RTO-K121 deembedding base option allows waveform correction based on S-parameters of the involved measurement blocks. The R&S®RTO-K121 option is available for R&S®RTO2022, R&S®RTO2024, R&S®RTO2032, R&S®RTO2034, R&S®RTO2044 and R&S®RTO2064 models only.	
Source	channel 1, channel 2, channel 3,	
	channel 4,	
Signal types	single-ended signals	
	differential signals based on two separate	
	cables by using two channels	
	full differential signals based on	
	differential probes	
S-parameter files	s2p-files and s4p-files	
Types of blocks	cables, connectors, fixtures and custome	
	defined blocks	
Maximum number of blocks	10	

Proven cable/proven probe

General description	The proven probe/proven cable is a part of the R&S®RTO-K121 deembedding base option. This function enables the user to determine the correction parameters of a cable or a modified probe based on the differential pulse source R&S®RTO-B7.	
Mode		proven cable proven probe (Rohde & Schwarz probes, user defined)
Configurations	proven cable	single ended
	proven probe	single ended, differential
Correction method	cable, user-defined probe	transmission (magnitude and phase)
	Rohde & Schwarz probe	transmission (magnitude and phase)
Maximal group delay of DUT		20 ns
Maximal length of cables (setup)		3 m
Source		step with amplitude of -200 mV

R&S®RTO-K130 TDR/TDT analysis

Time domain reflexion/time dom	nain transmission analysis option		
General description	The R&S®RTO-K130 TDR/TDT option is a measurement technique used to determine		
		the characteristics of electrical lines by observing reflected and/or transmitted	
	waveforms. Together, they provide a po		
		30 option is available for R&S®RTO2022,	
		RTO2034, R&S®RTO2044 and R&S®RTO2064	
	models only.		
Mode		TDR, TDT, TDR/TDT	
Configuration		single ended	
Signals		impedance/reflection coefficient	
Domain		time/distance	
Bandwidth	TDR and/or TDT, single ended		
	R&S®RTO2022, R&S®RTO2024	2 GHz	
	R&S®RTO2032, R&S®RTO2034	3 GHz	
	R&S®RTO2044	4 GHz	
	R&S®RTO2064	6 GHz	
Step amplitude		200 mV	
Repetition rate		50 Hz to 500 kHz	
		(depends on horizontal scale)	
Length of cable	max.	15 ns (\sim 3.2 m at ε_r = 2)	
-	min.	2 ns (\sim 0.4 m at ε_r = 2)	
Electrical length of short	range, adjustable by user	0 ns to 2 ns	
Reference impedance	single ended	50 Ω	
	differential	100 Ω	

R&S®RTO-K133 advanced jitter analysis

General description		The R&S®RTO-K133 option provides advanced jitter measurements and enables jitter separation. R&S®RTO-K133 option includes R&S®RTO-K12 option.		
Jitter separation	total jitter (TJ),	ass reas reas reasons		
one: coparation	deterministic jitter (DJ),			
	data dependent jitter (DDJ),			
	periodic jitter (PJ),			
		data dependent jitter plus periodic jitter (DDJ+PJ),		
	. , , , ,	random jitter (RJ),		
	(other) bounded uncorrelated jitter ((O)B			
	random jitter plus (other) bounded uncorrelated jitter (RJ+(O)BUJ)			
Accepted input signals	clock signals or data signals (NRZ)			
Reference clock	internal clock recovery (PLL first or seco	nd order constant clock or feed forward)		
Colorolloc Glock	or explicit clock signal	na order, constant clock of reed forward)		
Basic measurements	symbol rate, symbol duration, event cour	nt		
litter measurements	total jitter at bit error rate (TJ@BER)	value in seconds or unit interval		
muoi measurements	total filler at bit ellor rate (13@DER)	BER value selectable		
		between 10 ⁻³² and 10 ⁻¹		
	deterministic jitter (DJ, dual-dirac)	value in seconds or unit interval		
	duty cycle distortion (DCD)	value in seconds or unit interval		
	` ,	value in seconds or unit interval		
	inter symbol interference (ISI)			
	total jitter (TJ) corresponds to	peak-to-peak value and RMS value in		
	time interval error (TIE)	seconds or unit interval		
	deterministic jitter (DJ)	peak-to-peak value and RMS value in		
	data dan an dant "Wan (DD I)	seconds or unit interval		
	data dependent jitter (DDJ)	peak-to-peak value and RMS value in		
	· " " (D I)	seconds or unit interval		
	periodic jitter (PJ)	peak-to-peak value and RMS value in		
	data dan andari 200 andara ara da 200 an	seconds or unit interval		
	data dependent jitter plus periodic jitter	peak-to-peak value and RMS value in		
	(DDJ+PJ)	seconds or unit interval		
	periodic jitter components	amplitude, frequency,		
	1 (D.1)	direction (vertical or horizontal)		
	random jitter (RJ)	RMS value in seconds or unit interval		
	(other) bounded uncorrelated jitter	peak-to-peak value and RMS value in		
	((O)BUJ)	seconds or unit interval		
	(other) bounded uncorrelated jitter ((O)BUJ, dual-dirac)	value in seconds or unit interval		
	random jitter plus (other) bounded	peak-to-peak value and RMS value in		
	uncorrelated jitter (RJ+(O)BUJ)	seconds or unit interval		
Statistics	max. and min. values for each jitter mea	surement type		
litter result plots	histogram (rising edges only)	TJ, DJ, DDJ, PJ, RJ+OBUJ		
	histogram (falling edges only)	TJ, DJ, DDJ, PJ, RJ+OBUJ		
	histogram (both edges)	TJ, DJ, DDJ, PJ, RJ+OBUJ		
	TIE track	TJ, DDJ, PJ, RJ+OBUJ		
	power spectral density (PSD)	TJ, DDJ, PJ, RJ+OBUJ		
Additional result plots	step response	,		
•	bathtub	PJ and (O)BUJ removable from noise		
		bathtub		
	synthetic eye diagram	DD only, DD+P(h), DD+P(v), DD+P		

R&S®RTO-K134 advanced jitter and noise analysis

General description	separation. R&S®RTO-K134 option include	The R&S®RTO-K134 option provides advanced jitter and noise measurements and separation. R&S®RTO-K134 option includes advanced jitter analysis R&S®RTO-K133		
	option and basic jitter analysis R&S®RTO-	K12 option.		
Noise separation	total noise (TN),	total noise (TN),		
	deterministic noise (DN),			
	data dependent noise (DDN),			
	periodic noise (PN),			
	data dependent noise plus periodic noise (DDN+PN),			
	random noise (RN),			
	(other) bounded uncorrelated noise ((OBUN),			
	` '	,·		
Accepted input signals		random noise plus other (other) bounded uncorrelated noise (RN+(O)BUN) clock signals or data signals (NRZ)		
Reference clock	ŭ , ,	d order constant clock or food forward)		
	or explicit clock signal	·		
Basic measurements	symbol rate, symbol duration, event count			
Noise measurements	eye height at bit error rate (EN@BER)	absolute or relative,		
		BER value selectable		
		between 10 ⁻³² and 10 ⁻¹		
	level distortion (LD)	absolute or relative value		
	inter symbol interference noise (ISIN)	absolute or relative value		
	total noise (TN)	peak-to-peak value and RMS value, absolute or relative		
	deterministic noise (DN)	peak-to-peak value and RMS value, absolute or relative		
	data dependent noise (DDN)	peak-to-peak value and RMS value, absolute or relative		
	periodic noise (PN)	peak-to-peak value and RMS value, absolute or relative		
	data dapandant naisa plua pariadia naisa			
	data dependent noise plus periodic noise (DDN+PN)	peak-to-peak value and RMS value, absolute or relative		
	periodic noise components	amplitude, frequency,		
		direction (vertical or horizontal)		
	random noise (RN)	RMS value, absolute or relative		
	(other) bounded uncorrelated noise ((O)BUN)	peak-to-peak value and RMS value, absolute or relative		
	(other) bounded uncorrelated noise ((O)BUN, dual-dirac)	absolute or relative value		
	random noise plus (other) bounded	peak-to-peak value and RMS value,		
	uncorrelated noise (RJ+(O)BUN)	absolute or relative		
Statistics	max. and min. values for each noise meas			
Noise result plots	histogram (level 0)	TN, DN, DDN, PN, RN+OBUN		
tolog rount plots	histogram (level 1)	TN, DN, DDN, PN, RN+OBUN		
	, , ,			
	histogram (both levels)	TN, DN, DDN, PN, RN+OBUN		
	TIE track	TN, DDN, PN, RN+OBUN		
A 1 Pet	power spectral density (PSD)	TN, DDN, PN, RN+OBUN		
Additional result plots	step responses			
	noise bathtub	PN and (O)BUN removable from noise bathtub		
	synthetic eye diagram	DD only, DD+P(h), DD+P(v), DD+P		

Ordering information

Designation	Туре	Order No.
Base unit (including standard accessories: 500 MHz passive probe (10:1) per channel,	accessories bag, quic	k start guide,
CD with manual, power cord)		
Oscilloscope		
600 MHz, 10 Gsample/s, 50/100 Msample, 2 channels	R&S®RTO2002	1329.7002.02
600 MHz, 10 Gsample/s, 50/200 Msample, 4 channels	R&S®RTO2004	1329.7002.04
1 GHz, 10 Gsample/s, 50/100 Msample, 2 channels	R&S®RTO2012	1329.7002.12
1 GHz, 10 Gsample/s, 50/200 Msample, 4 channels	R&S®RTO2014	1329.7002.14
2 GHz, 10 Gsample/s, 50/100 Msample, 2 channels	R&S®RTO2022	1329.7002.22
2 GHz, 10 Gsample/s, 50/200 Msample, 4 channels	R&S®RTO2024	1329.7002.24
3 GHz, 10 Gsample/s, 50/100 Msample, 2 channels	R&S®RTO2032	1329.7002.32
3 GHz, 10 Gsample/s, 50/200 Msample, 4 channels	R&S®RTO2034	1329.7002.34
4 GHz, 20 Gsample/s, 50/200 Msample, 4 channels	R&S®RTO2044	1329.7002.44
6 GHz, 20 Gsample/s, 50/200 Msample, 4 channels	R&S®RTO2064	1329.7002.64
Hardware options (plug-in)		
Mixed signal option, 400 MHz, 5 Gsample/s, 16 channels	R&S®RTO-B1	1326.3558.02
Digital extension port for R&S®RT-ZVC usage with R&S®RTO oscilloscope,	R&S®RTO-B1E	1333.0738.02
included in R&S®RTO-B1		
OCXO 10 MHz	R&S®RTO-B4	1304.8305.02
Arbitrary waveform generator, 100 MHz, 2 analog channels, 8-bit pattern generator	R&S®RTO-B6	1329.7054.02
16 GHz differential pulse source	R&S®RTO-B7	1333.2030.02
GPIB interface	R&S®RTO-B10	1304.8311.03
Additional solid state disk	R&S®RTO-B19	1329.7048.02
Memory upgrade, 100 Msample per channel	R&S®RTO-B101	1329.7060.02
Memory upgrade, 200 Msample per channel	R&S®RTO-B102	1329.7077.02
Memory upgrade, 400 Msample per channel	R&S®RTO-B104	1329.7083.02
Memory upgrade, 1 Gsample per channel, for R&S®RTO2002/12/22/32	R&S®RTO-B110	1329.7090.02
Memory upgrade, 1 Gsample per channel, for R&S®RTO2004/14/24/34/44/64	R&S®RTO-B110	1329.7090.04
Bandwidth upgrades ¹⁷	rao ri o bi i o	1020.1000.01
Upgrade of the R&S®RTO2002/4 to 1 GHz bandwidth	R&S®RTO-B201	1329.7102.02
Upgrade of the R&S®RTO2002/4 to 2 GHz bandwidth	R&S®RTO-B202	1329.7119.02
Upgrade of the R&S®RTO2002/4 to 3 GHz bandwidth	R&S®RTO-B203	1329.7125.02
Upgrade of the R&S®RTO2004 to 4 GHz bandwidth	R&S®RTO-B204	1329.7131.02
Upgrade of the R&S®RTO2004 to 6 GHz bandwidth	R&S®RTO-B204	1329.7148.02
Upgrade of the R&S®RTO2012/4 to 2 GHz bandwidth	R&S®RTO-B212	1329.7154.02
Upgrade of the R&S®RTO2012/4 to 3 GHz bandwidth	R&S®RTO-B213	1329.7160.02
	R&S®RTO-B214	
Upgrade of the R&S®RTO2014 to 4 GHz bandwidth	R&S®RTO-B214	1329.7177.02
Upgrade of the R&S®RTO2014 to 6 GHz bandwidth Upgrade of the R&S®RTO2022/4 to 3 GHz bandwidth		1329.7183.02
	R&S®RTO-B223	1329.7190.02
Upgrade of the R&S®RTO2022/4 to 4 GHz bandwidth	R&S®RTO-B224	1329.7202.02
Upgrade of the R&S®RTO2024 to 6 GHz bandwidth	R&S®RTO-B226	1329.7219.02
Upgrade of the R&S®RTO2034 to 4 GHz bandwidth	R&S®RTO-B234	1329.7225.02
Upgrade of the R&S®RTO2034 to 6 GHz bandwidth	R&S®RTO-B236	1329.7231.02
Upgrade of the R&S®RTO2044 to 6 GHz bandwidth	R&S®RTO-B246	1329.7248.02
Software options		
Serial triggering and decoding	D 0 00 D T 0 1//	
I ² C/SPI serial triggering and decoding	R&S®RTO-K1	1329.7260.02
UART/RS-232/RS-422/RS-485 serial triggering and decoding	R&S®RTO-K2	1329.7277.02
CAN/LIN serial triggering and decoding	R&S®RTO-K3	1329.7283.02
FlexRay™ serial triggering and decoding	R&S®RTO-K4	1329.7290.02
I ² S serial triggering and decoding	R&S®RTO-K5	1329.7302.02
MIL-STD-1553 serial triggering and decoding	R&S®RTO-K6	1329.7319.02
ARINC 429 serial triggering and decoding	R&S®RTO-K7	1329.7325.02
Ethernet (10BASE-T/100BASE-TX) serial triggering and decoding	R&S®RTO-K8	1329.7331.02
CAN-FD serial triggering and decoding	R&S®RTO-K9	1329.7348.02
SENT serial triggering and decoding	R&S®RTO-K10	1329.7354.02
User-defined math with Python	R&S®RTO-K39	1803.6784.02
MIPI RFFE serial triggering and decoding	R&S®RTO-K40	1329.7519.02
MIPI D-PHY serial triggering and decoding	R&S®RTO-K42	1329.7525.02
MIPI M-PHY serial triggering and decoding	R&S®RTO-K44	1333.0267.02
Manchester and NRZ serial triggering and decoding	R&S®RTO-K50	1329.7531.02

¹⁷ The bandwidth upgrade is performed at a Rohde & Schwarz service center, where the oscilloscope will also be calibrated.

8b10b serial triggering and decoding MDIO serial triggering and decoding Ethernet (100BASE-T1) serial triggering and decoding Ethernet (1000BASE-T1) serial triggering and decoding USB 1.0/1.1/2.0/HSIC serial triggering and decoding USB 3.1 Gen 1 serial triggering and decoding USB power delivery serial triggering and decoding USB 3.1 SSIC serial triggering and decoding USB 3.1 SSIC serial triggering and decoding SpaceWire serial triggering and decoding PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding CxPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test PCI Express 1.1/2.0 compliance test Ethernet compliance test (1000BASE-T1)	R&S®RTO-K52 R&S®RTO-K55 R&S®RTO-K57 R&S®RTO-K58 R&S®RTO-K60 R&S®RTO-K61 R&S®RTO-K63 R&S®RTO-K64 R&S®RTO-K65 R&S®RTO-K72 R&S®RTO-K72 R&S®RTO-K72 R&S®RTO-K76	1329.7548.02 1329.7554.02 1333.0596.02 1801.4503.02 1329.7560.02 1326.3112.02 1326.3135.02 1337.9123.02 1326.2868.02 1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02 1329.7483.02
Ethernet (100BASE-T1) serial triggering and decoding Ethernet (1000BASE-T1) serial triggering and decoding USB 1.0/1.1/2.0/HSIC serial triggering and decoding USB 3.1 Gen 1 serial triggering and decoding USB power delivery serial triggering and decoding USB 3.1 SSIC serial triggering and decoding SpaceWire serial triggering and decoding PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding CXPI serial triggering and decoding CXPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K57 R&S®RTO-K58 R&S®RTO-K60 R&S®RTO-K61 R&S®RTO-K63 R&S®RTO-K64 R&S®RTO-K65 R&S®RTO-K72 R&S®RTO-K76 R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1333.0596.02 1801.4503.02 1329.7560.02 1326.3112.02 1326.3135.02 1337.9123.02 1326.2868.02 1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
Ethernet (1000BASE-T1) serial triggering and decoding USB 1.0/1.1/2.0/HSIC serial triggering and decoding USB 3.1 Gen 1 serial triggering and decoding USB power delivery serial triggering and decoding USB 3.1 SSIC serial triggering and decoding SpaceWire serial triggering and decoding PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding CXPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K58 R&S®RTO-K60 R&S®RTO-K61 R&S®RTO-K63 R&S®RTO-K64 R&S®RTO-K65 R&S®RTO-K72 R&S®RTO-K76 R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1801.4503.02 1329.7560.02 1326.3112.02 1326.3135.02 1337.9123.02 1326.2868.02 1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
USB 1.0/1.1/2.0/HSIC serial triggering and decoding USB 3.1 Gen 1 serial triggering and decoding USB power delivery serial triggering and decoding USB 3.1 SSIC serial triggering and decoding SpaceWire serial triggering and decoding PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding CXPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K60 R&S®RTO-K61 R&S®RTO-K63 R&S®RTO-K64 R&S®RTO-K65 R&S®RTO-K72 R&S®RTO-K76 R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1329.7560.02 1326.3112.02 1326.3135.02 1337.9123.02 1326.2868.02 1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
USB 3.1 Gen 1 serial triggering and decoding USB power delivery serial triggering and decoding USB 3.1 SSIC serial triggering and decoding SpaceWire serial triggering and decoding PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding CxPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K61 R&S®RTO-K63 R&S®RTO-K64 R&S®RTO-K65 R&S®RTO-K72 R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1326.3112.02 1326.3135.02 1337.9123.02 1326.2868.02 1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
USB power delivery serial triggering and decoding USB 3.1 SSIC serial triggering and decoding SpaceWire serial triggering and decoding PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K63 R&S®RTO-K64 R&S®RTO-K65 R&S®RTO-K72 R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1326.3135.02 1337.9123.02 1326.2868.02 1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
USB 3.1 SSIC serial triggering and decoding SpaceWire serial triggering and decoding PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K64 R&S®RTO-K65 R&S®RTO-K72 R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1337.9123.02 1326.2868.02 1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
SpaceWire serial triggering and decoding PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K65 R&S®RTO-K72 R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1326.2868.02 1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
PCI Express 1.1/2.0 serial triggering and decoding CXPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K72 R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1326.3741.02 1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
CXPI serial triggering and decoding Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K76 R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1326.3170.02 1329.7454.02 1329.7460.02 1329.7477.02
Compliance tests USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K21 R&S®RTO-K22 R&S®RTO-K23 R&S®RTO-K24	1329.7454.02 1329.7460.02 1329.7477.02
USB 2.0 compliance test Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S [®] RTO-K22 R&S [®] RTO-K23 R&S [®] RTO-K24	1329.7460.02 1329.7477.02
Ethernet compliance test (10/100/1000BASE-T/EEE) Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S [®] RTO-K22 R&S [®] RTO-K23 R&S [®] RTO-K24	1329.7460.02 1329.7477.02
Ethernet compliance test (2.5/5/10GBASE-T) Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K23 R&S®RTO-K24	1329.7477.02
Ethernet compliance test (100BASE-T1) MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	R&S®RTO-K24	
MIPI D-PHY compliance test MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test		1379 7483 [17
MIPI D-PHY 2.5 compliance test PCI Express 1.1/2.0 compliance test	1140 1110 1120	1329.7490.02
PCI Express 1.1/2.0 compliance test	R&S®RTO-K27	1803.6584.02
	R&S®RTO-K81	1326.0920.02
	R&S®RTO-K87	1337.8591.02
Ethernet compliance test (1000BASE-T1) Ethernet compliance test (MGBASE-T1)	R&S®RTO-K88	1801.4526.02
Ethernet compliance test (MOBASE-T1)	R&S®RTO-K89	1801.4510.02
DDR3/DDR3L/LPDDR3 signal integrity debug and compliance test	R&S®RTO-K91	1337.8891.02
eMMC compliance test	R&S®RTO-K92	1333.0444.02
R&S®ScopeSuite automation	R&S®RTO-K99	1326.4419.02
Analysis		1020.1710.02
I/Q software interface	R&S®RTO-K11	1329.7360.02
Jitter analysis	R&S®RTO-K12	1329.7377.02
Clock data recovery	R&S®RTO-K13	1329.7383.02
Spectrum analysis	R&S®RTO-K18	1329.7425.02
Zone trigger	R&S®RTO-K19	1329.7431.02
Power analysis	R&S®RTO-K31	1329.7502.02
Bus analysis	R&S®RTO-K35	1801.2846.02
Deembedding base option	R&S®RTO-K121	1326.3058.02
TDR/TDT analysis	R&S®RTO-K130	1326.3087.02
Advanced jitter analysis	R&S®RTO-K133	1801.4832.02
Advanced jitter and noise analysis	R&S®RTO-K134	1802.9450.02
Vindows 10 upgrade	R&S®RTO-U2	1801.3836.02
Probes		
500 MHz, passive, 10:1, 1 MΩ, 9.5 pF, max. 400 V	R&S®RT-ZP10	1409.7550.00
00 MHz, passive, high-voltage, 100:1, 50 MΩ, 7.5 pF, 1 kV (RMS)	R&S®RT-ZH10	1409.7720.02
00 MHz, passive, high-voltage, 1000:1, 50 MΩ, 7.5 pF, 1 kV (RMS)	R&S®RT-ZH11	1409.7737.02
3.0 GHz, passive, transmission line, 10:1, 500 Ω, 0.3 pF, 20 V (RMS)	R&S®RT-ZZ80	1409.7608.02
.0 GHz, active, 1 M Ω 0.8 pF	R&S®RT-ZS10E	1418.7007.02
.0 GHz, active, 1 MΩ 0.8 pF, R&S®ProbeMeter, micro button	R&S®RT-ZS10	1410.4080.02
.5 GHz, active, 1 MΩ 0.8 pF, R&S®ProbeMeter, micro button	R&S®RT-ZS20	1410.3502.02
3.0 GHz, active, 1 MΩ 0.8 pF, R&S®ProbeMeter, micro button	R&S®RT-ZS30	1410.4309.02
5.0 GHz, active, 1 MΩ 0.3 pF, R&S®ProbeMeter, micro button	R&S®RT-ZS60	1418.7307.02
.5 GHz, active, differential, 1 MΩ 0.6 pF, R&S®ProbeMeter, micro button	R&S®RT-ZD20	1410.4409.02
3.0 GHz, active, differential, 1 MΩ 0.6 pF, R&S®ProbeMeter, micro button	R&S®RT-ZD30	1410.4609.02
.5 GHz, active, differential, 1 MΩ 0.4 pF, R&S®ProbeMeter, micro button	R&S®RT-ZD40	1410.5205.02
0 MHz, current, AC/DC, 0.01 V/A, 150 A (RMS)	R&S®RT-ZC10	1409.7750.02
00 MHz, current, AC/DC, 0.1 V/A, 30 A (RMS)	R&S®RT-ZC20	1409.7766.02
20 MHz, AC/DC, 1 V/A, 5 A (RMS)	R&S®RT-ZC30	1409.7772K02
MHz, current, AC/DC, 0.01 V/A, 500 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC05B	1409.8204.02
0 MHz, current, AC/DC, 0.01 V/A, 150 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC10B	1409.8210.02
60 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC15B	1409.8227.02
00 MHz, current, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC20B	1409.8233.02
//ulti-channel power probe, 2 × 4 voltage/current channels, or R&S®RTO2000/R&S®RTE	R&S®RT-ZVC04	1326.0259.04
//ulti-channel power probe, 2 × 2 voltage/current channels, or R&S®RTO2000/R&S®RTE	R&S®RT-ZVC02	1326.0259.02
Probe set for E and H near-field measurements, two passive E and three passive H lear-field proves, 30 MHz to 3 GHz	R&S®HZ-15	1147.2736.02
Probe set for H near-field measurements, two passive H near-field probes, 0 MHz to 3 GHz	R&S®HZ-17	1339.4141.02

Designation	Туре	Order No.
Probe accessories		
Accessory set for R&S®RT-ZP10 passive probe (2.5 mm probe tip)	R&S®RT-ZA1	1409.7566.00
Spare accessory set for R&S®RT-ZS10/10E/20/30	R&S®RT-ZA2	1416.0405.02
Pin set for R&S®RT-ZS10/10E/20/30	R&S®RT-ZA3	1416.0411.02
Mini clips	R&S®RT-ZA4	1416.0428.02
Micro clips	R&S®RT-ZA5	1416.0434.02
Lead set	R&S®RT-ZA6	1416.0440.02
Pin set for R&S [®] RT-ZD20/30	R&S®RT-ZA7	1417.0609.02
Pin set for R&S®RT-ZD40	R&S®RT-ZA8	1417.0867.02
Probe box to N/USB adapter	R&S®RT-ZA9	1417.0909.02
Adapter SMA(f) to BNC(m)	R&S®RT-ZA10	1416.0457.02
Probe power supply	R&S®RT-ZA13	1409.7789.02
External attenuator, 10:1, 2.0 GHz, 70 V DC, 46 V AC (peak)	R&S®RT-ZA15	1410.4744.02
Extended cable set for R&S®RT-ZVC, PCB probing, 1 current and voltage lead, length: 32 cm	R&S®RT-ZA30	1333.1686.02
Extended cable set for R&S®RT-ZVC, 4 mm probing, 1 current and voltage lead, length: 32 cm	R&S®RT-ZA31	1333.1692.02
Oscilloscope interface cable for R&S®RT-ZVC (included in R&S®RT-ZVC02/-ZVC04, 1326.0259.02/.04)	R&S®RT-ZA33	1333.1770.02
Extended cable set for R&S®RT-ZVC, 4 mm probing, 1 current and voltage lead, length: 1 m	R&S®RT-ZA34	1333.1892.02
Extended cable set for R&S®RT-ZVC, PCB probing, 1 current and voltage lead, length: 1 m	R&S®RT-ZA35	1333.1905.02
Solder-in cable set for R&S®RT-ZVC, 4 current and voltage solder-in cables, solder-in pins	R&S®RT-ZA36	1333.1911.02
Extended cable set for R&S®RT-ZVC, BNC connector, 1 current and voltage lead, length: 16 cm	R&S®RT-ZA37	1337.9130.02
Accessories		
Front cover, for R&S®RTO oscilloscopes	R&S®RTO-Z1	1333.0096.02
Soft case, for R&S®RTO oscilloscopes and accessories	R&S®RTO-Z3	1304.9118.02
Transit case, for R&S®RTO/RTE oscilloscopes and accessories	R&S®RTO-Z4	1317.7025.02
Probe pouch, for R&S®RTO oscilloscopes	R&S®RTO-Z5	1317.7023.02
USB 2.0 compliance test fixture set	R&S®RT-ZF1	1317.7031.02
Ethernet compliance test fixture set	R&S®RT-ZF2	1317.5522.02
Ethernet 1000BASE-T1 jitter test cable	R&S®RT-ZF2C	1317.5639.02
Frequency converter (100BASE-T1)	R&S®RT-ZF3	5025.0670.02
Ethernet 10BASE-Te fixture	R&S®RT-ZF4	1333.0915.02
Ethernet Probe fixture	R&S®RT-ZF5	1333.0938.02
Frequency converter (1000BASE-T1)	R&S®RT-ZF6	1337.8579.02
Automotive Ethernet T&D fixture	R&S®RT-ZF6	1801.3688.02
	R&S®RT-ZF7	
SMA adapter SMA adapter for PoDL	R&S®RT-ZF7A	1801.4126.02
	R&S®RT-ZF7P	1802.9680.02 1801.3694.02
Automotive Ethernet compliance fixture		
Probe deskew and calibration test fixture	R&S®RT-ZF20	1800.0004.02
3 GHz, 20 dB preamplifier, 100 V to 230 V power adapter, for R&S®HZ-15	R&S®HZ-16	1147.2720.02
19" rackmount kit, for R&S®RTO oscilloscopes with 6 HU	R&S®ZZA-RTO	1304.8286.00

Warranty		
Base unit		3 years
All other items ¹⁸		1 year
Service options		
Extended warranty, one year	R&S®WE1	Please contact
Extended warranty, two years	R&S®WE2	your local
Extended warranty with calibration coverage, one year	R&S®CW1	Rohde & Schwarz
Extended warranty with calibration coverage, two years	R&S®CW2	sales office.
Extended warranty with accredited calibration coverage, one year	R&S®AW1	
Extended warranty with accredited calibration coverage, two years	R&S®AW2	

Extended warranty with a term of one and two years (WE1 and WE2)

Repairs carried out during the contract term are free of charge ¹⁹. Necessary calibration and adjustments carried out during repairs are also covered.

Extended warranty with calibration coverage (CW1 and CW2)

Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated, inspected and maintained during the term of the contract. It includes all repairs ¹⁹ and calibration at the recommended intervals as well as any calibration carried out during repairs or option upgrades.

Extended warranty with accredited calibration (AW1 and AW2)

Enhance your extended warranty by adding accredited calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated under accreditation, inspected and maintained during the term of the contract. It includes all repairs ¹⁹ and accredited calibration at the recommended intervals as well as any accredited calibration carried out during repairs or option upgrades.

¹⁸ For options installed, the remaining base unit warranty applies if longer than 1 year. Exception: all batteries have a 1 year warranty.

¹⁹ Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

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- Local and personalized
 Customized and flexible
 Uncompromising quality
 Long-term dependability



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